TLE206x, TLE206xA, TLE206xB, TLE206xY EXCALIBUR JFET-INPUT HIGH-OUTPUT-DRIVE μPOWER OPERATIONAL AMPLIFIERS

SLOS193A – FEBRUARY 1997 – REVISED MARCH 1998

- **2× Bandwidth (2 MHz) of the TL06x and TL03x Operational Amplifiers**
- **Low Supply Current . . . 290 μA/Ch Typ**
- **On-chip Offset Voltage Trimming for Improved DC Performance**
- **High Output Drive, Specified into 100-Ω Loads**
- **Lower Noise Floor Than Earlier Generations of Low-Power BiFETs**

description

The TLE206x series of low-power JFET-input operational amplifiers doubles the bandwidth of the earlier generation TL06x and TL03x BiFET families without significantly increasing power consumption. Texas Instruments Excalibur process also delivers a lower noise floor than the TL06x and TL03x. On-chip zener trimming of offset voltage yields precision grades for dc-coupled applications. The TL206x devices are pin-compatible with other TI BiFETs; they can be used to double the bandwidth of TL06x and TL03x circuits, or to reduce power consumption of TL05x, TL07x, and TL08x circuits by nearly 90%.

BiFET operational amplifiers offer the inherently-higher input impedance of the JFET-input transistors, without sacrificing the output drive associated with bipolar amplifiers. This makes them better suited for interfacing with high-impedance sensors or very low-level ac signals. They also feature inherently better ac response than bipolar or CMOS devices having comparable power consumption. The TLE206x family features a high-output-drive circuit capable of driving 100-Ω loads at supplies as low as ±5 V. This makes them uniquely suited for driving transformer loads in modems and other applications requiring good ac characteristics, low power, and high output drive.

Because BiFET operational amplifiers are designed for use with dual power supplies, care must be taken to observe common-mode input voltage limits and output swing when operating from a single supply. DC biasing of the input signal is required and loads should be terminated to a virtual ground node at mid-supply. Texas Instruments TLE2426 integrated virtual ground generator is useful when operating BiFET amplifiers from single supplies.

The TLE206x are fully specified at ±15 V and ±5 V. For operation in low-voltage and/or single-supply systems, Texas Instruments LinCMOS families of operational amplifiers (TLC- and TLV-prefixes) are recommended. When moving from BiFET to CMOS amplifiers, particular attention should be paid to slew rate and bandwidth requirements, and output loading. The Texas Instrument TLV2432 and TLV2442 CMOS operational amplifiers are excellent choices to consider.

TLE2061 AVAILABLE OPTIONS

PACKAGED DEVICES							CHIP FORM§ (Y)
T_A	V_{IO}max AT 25°C	SMALL OUTLINE† (D)	CHIP CARRIER (FK)	CERAMIC DIP (JG)	PLASTIC DIP (P)	TSSOP‡ (PW)	
0°C to 70°C	500 μV	—	—	—	—	—	—
	1.5 mV	TLE2061ACD	—	—	TLE2061ACP	—	—
	3 mV	TLE2061CD	—	—	TLE2061CP	TLE2061CPWLE	TLE2061Y
–40°C to 85°C	500 μV	—	—	—	—	—	—
	1.5 mV	TLE2061AID	—	—	TLE2061AIP	—	—
	3 mV	TLE2061ID	—	—	TLE2061IP	—	—
–55°C to 125°C	500 μV	—	—	TLE2061BMJG	—	—	—
	1.5 mV	TLE2061AMD	TLE2061AMFK	TLE2061AMJG	TLE2061AMP	—	—
	3 mV	TLE2061MD	TLE2061MFK	TLE2061MJG	TLE2061MP	—	—

† The D packages are available taped and reeled. Add R suffix to device type (e.g., TLE2061ACDR).Chips are tested at 25°C.
‡ The PW package is available left-end taped and reeled (indicated by the LE suffix on the device type (e.g., TLE2061CPWLE).
§ Chip forms are tested at 25°C only.

TLE2062 AVAILABLE OPTIONS

PACKAGED DEVICES						CHIP FORM‡ (Y)
T_A	V_{IO}max AT 25°C	SMALL OUTLINE† (D)	CHIP CARRIER (FK)	CERAMIC DIP (JG)	PLASTIC DIP (P)	
0°C to 70°C	1 mV	TLE2062BCD	—	—	TLE2062BCP	—
	2 mV	TLE2062ACD	—	—	TLE2062ACP	—
	4 mV	TLE2062CD	—	—	TLE2062CP	TLE2062Y
–40°C to 85°C	1 mV	TLE2062BID	—	—	TLE2062BIP	—
	2 mV	TLE2062AID	—	—	TLE2062AIP	—
	4 mV	TLE2062ID	—	—	TLE2062IP	—
–55°C to 125°C	1 mV	TLE2062BMD	TLE2062BMFK	TLE2062BMJG	TLE2062BMP	—
	2 mV	TLE2062AMD	TLE2062AMFK	TLE2062AMJG	TLE2062AMP	—
	4 mV	TLE2062MD	TLE2062MFK	TLE2062MJG	TLE2062MP	—

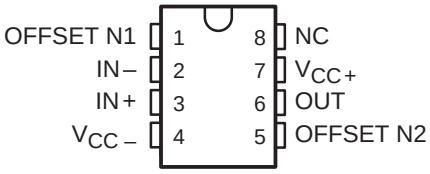
† The D packages are available taped and reeled. Add R suffix to device type (e.g., TLE2062ACDR).
‡ Chip forms are tested at 25°C only.

TLE2064 AVAILABLE OPTIONS

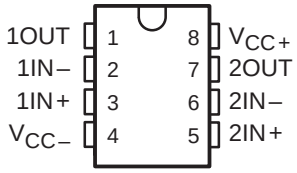
PACKAGED DEVICES						CHIP FORM‡ (Y)
T_A	V_{IO}max AT 25°C	SMALL OUTLINE† (D)	CHIP CARRIER (FK)	CERAMIC DIP (J)	PLASTIC DIP (N)	
0°C to 70°C	2 mV	—	—	—	TLE2064BCN	—
	4 mV	TLE2064ACD			TLE2064ACN	—
	6 mV	TLE2064CD			TLE2064CN	TLE2064Y
–40°C to 85°C	2 mV	—	—	—	TLE2064BIN	—
	4 mV	TLE2064AID			TLE2064AIN	—
	6 mV	TLE2064ID			TLE2064IN	—
–55°C to 125°C	2 mV	—	—	TLE2064BMJ	TLE2064BMN	—
	4 mV	TLE2064AMD	TLE2064AMFK	TLE2064AMJ	TLE2064AMN	—
	6 mV	TLE2064MD	TLE2064MFK	TLE2064MJ	TLE2064MN	—

† The D packages are available taped and reeled. Add R suffix to device type, (e.g., TLE2064ACDR).
‡ Chip forms are tested at 25°C only.

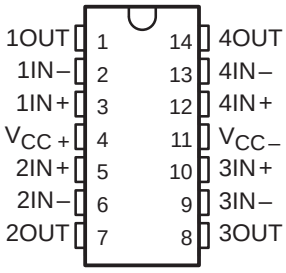
TLE2061, TLE2061A, AND TLE2061B
D, DB, JG, P, OR PW PACKAGE
(TOP VIEW)



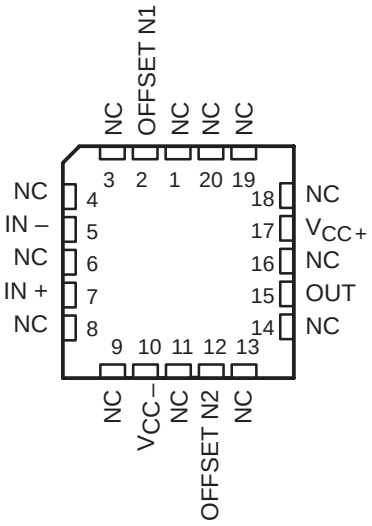
TLE2062, TLE2062A, TLE2062B
D, JG, OR P PACKAGE
(TOP VIEW)



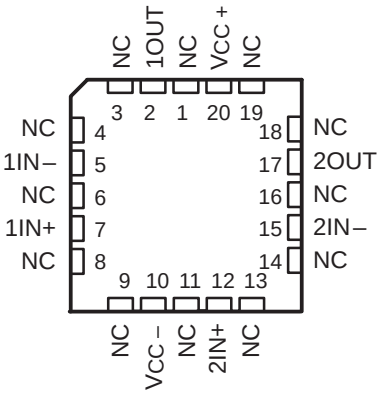
TLE2064, TLE2064A, TLE2064B
D, J, OR N PACKAGE
(TOP VIEW)



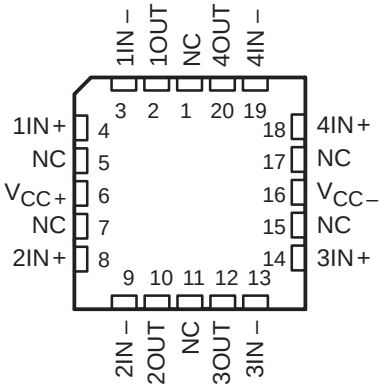
TLE2061M, TLE2061AM, TLE2061BM
FK PACKAGE
(TOP VIEW)



TLE2062M, TLE2062AM, TLE2062BM
FK PACKAGE
(TOP VIEW)



TLE2064M, TLE2064AM, TLE2064BM
FK PACKAGE
(TOP VIEW)

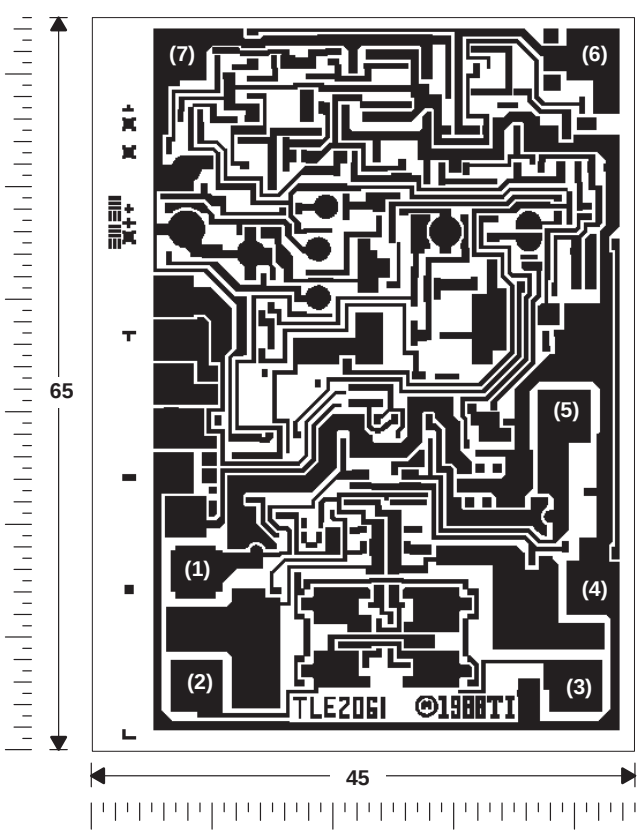


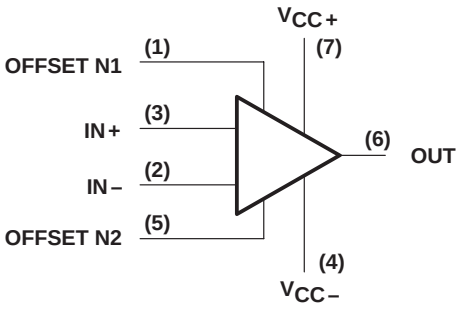
NC – No internal connection

TLE2061Y chip information

This chip, when properly assembled, displays characteristics similar to the TLE2061. Thermal compression or ultrasonic bonding may be used on the doped-aluminum bonding pads. Chips may be mounted with conductive epoxy or a gold-silicon preform.

BONDING PAD ASSIGNMENTS





CHIP THICKNESS: 15 MILS TYPICAL

BONDING PADS: 4 X 4 MILS MINIMUM

$T_J$max = 150°C

TOLERANCES ARE ± 10%.

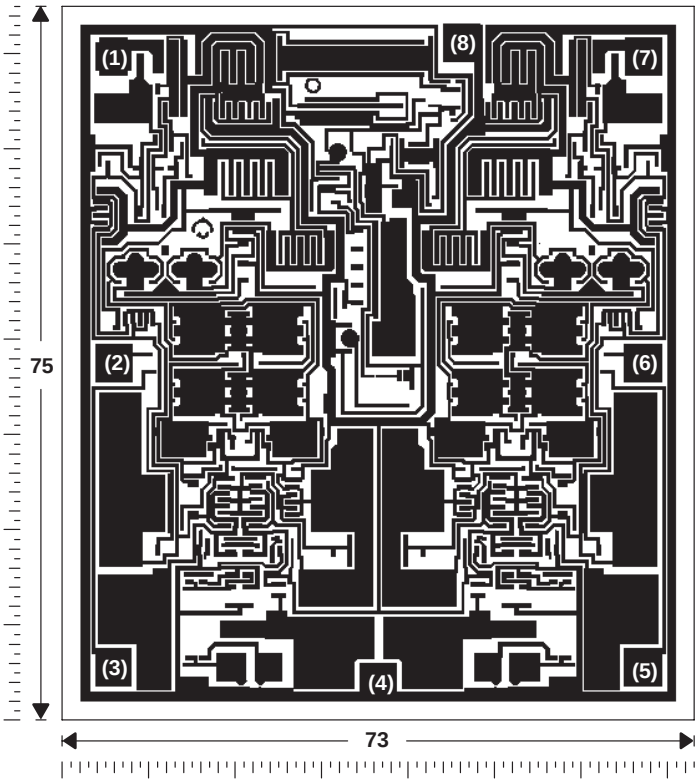
ALL DIMENSIONS ARE IN MILS.

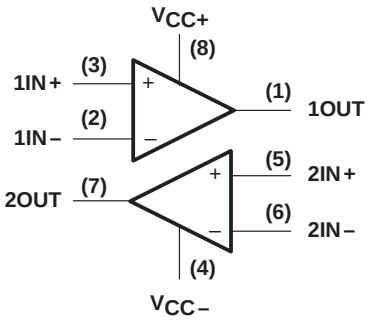
PIN (4) IS INTERNALLY CONNECTED TO BACKSIDE OF CHIP.

TLE2062Y chip information

This chip, when properly assembled, displays characteristics similar to the TLE2062. Thermal compression or ultrasonic bonding may be used on the doped-aluminum bonding pads. Chips may be mounted with conductive epoxy or a gold-silicon preform.

BONDING PAD ASSIGNMENTS





CHIP THICKNESS: 15 MILS TYPICAL

BONDING PADS: 4 × 4 MILS MINIMUM

$T_J$max = 150°C

TOLERANCES ARE ±10%.

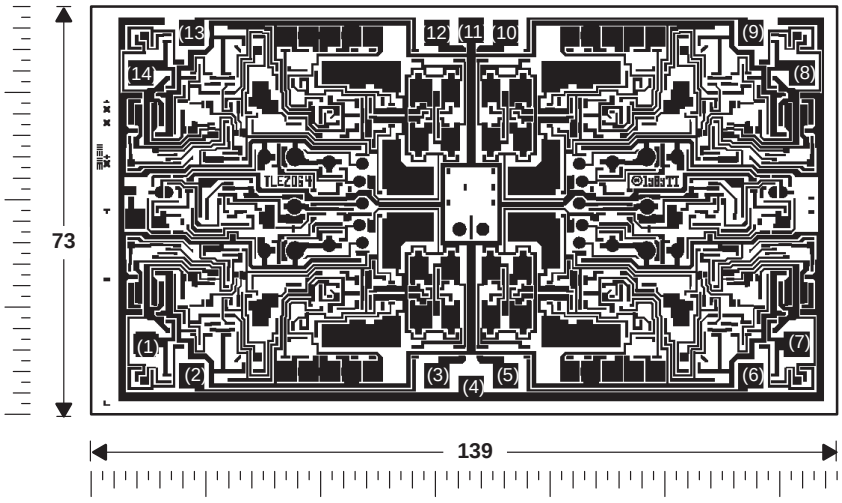
ALL DIMENSIONS ARE IN MILS.

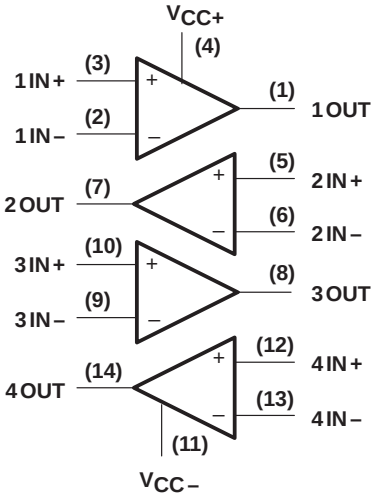
PIN (4) IS INTERNALLY CONNECTED TO BACKSIDE OF THE CHIP.

TLE2064Y chip information

This chip, when properly assembled, displays characteristics similar to the TLE2064. Thermal compression or ultrasonic bonding may be used on the doped-aluminum bonding pads. Chips may be mounted with conductive epoxy or a gold-silicon preform.

BONDING PAD ASSIGNMENTS





CHIP THICKNESS: 15 MILS TYPICAL

BONDING PADS: 4 × 4 MILS MINIMUM

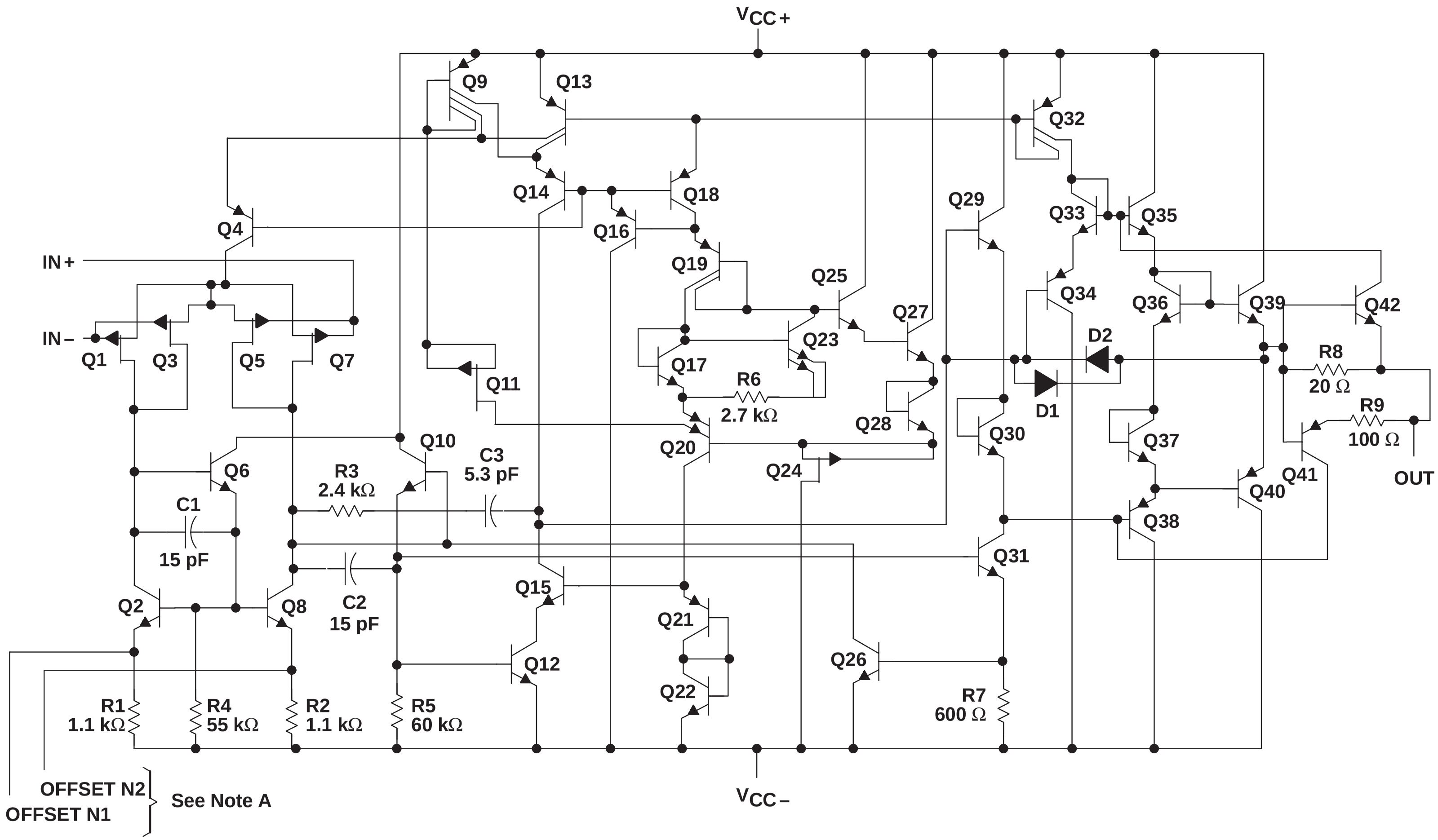
$T_J$max = 150°C

TOLERANCES ARE ±10%.

ALL DIMENSIONS ARE IN MILS.

PIN (11) IS INTERNALLY CONNECTED TO BACKSIDE OF CHIP.

equivalent schematic (each channel)



NOTES: A. OFFSET N1 AND OFFSET N2 are only availiable on the TLE2061x devices.
B. Component values are nominal.

ACTUAL DEVICE COMPONENT COUNT			
COMPONENT	TLE2061	TLE2062	TLE2064
Transistors	43	42	42
Resistors	9	9	9
Diodes	1	2	2
Capacitors	3	3	3

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V_{CC+} (see Note 1) . . . . . 19 V
Supply voltage, V_{CC-} . . . . . –19 V
Differential input voltage, V_{ID} (see Note 2) . . . . . ±38 V
Input voltage range, V_I (any input) . . . . . $\pm V_{CC}$
Input current, I_I (each input) . . . . . ±1 mA
Output current, I_O . . . . . ±80 mA
Total current into V_{CC+} . . . . . 80 mA
Total current out of V_{CC-} . . . . . –80 mA
Duration of short-circuit current at (or below) 25°C (see Note 3) . . . . . unlimited
Continuous total dissipation . . . . . See Dissipation Rating Table
Operating free-air temperature range, T_A: C suffix . . . . . 0°C to 70°C
I suffix . . . . . –40°C to 85°C
M suffix . . . . . –55°C to 125°C
Storage temperature range . . . . . –65°C to 150°C
Case temperature for 60 seconds: FK package . . . . . 260°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds: D, P, or PW package . . . . . 260°C
Lead temperature 1,6 mm (1/16 inch) from case for 60 seconds: JG package . . . . . 300°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values, except differential voltages, are with respect to the midpoint between V_{CC+} and V_{CC-}.
2. Differential voltages are at IN+ with respect to IN–.
3. The output may be shorted to either supply. Temperature and/or supply voltages must be limited to ensure that the maximum dissipation rating is not exceeded.

DISSIPATION RATING TABLE

PACKAGE	$T_A \le 25°C$ POWER RATING	DERATING FACTOR ABOVE $T_A = 25°C$	$T_A = 70°C$ POWER RATING	$T_A = 85°C$ POWER RATING	$T_A = 125°C$ POWER RATING
D–8	725 mW	5.8 mW/°C	464 mW	377 mW	145 mW
D–14	950 mW	7.6 mW/°C	608 mW	494 mW	190 mW
FK	1375 mW	11.0 mW/°C	880 mW	715 mW	275 mW
J	1375 mW	11.0 mW/°C	880 mW	715 mW	275 mW
JG	1050 mW	8.4 mW/°C	672 mW	546 mW	210 mW
N	1150 mW	9.2 mW/°C	736 mW	598 mW	230 mW
P	1000 mW	8.0 mW/°C	640 mW	520 mW	200 mW
PW	525 mW	4.2 mW/°C	336 mW	—	—

recommended operating conditions

		C SUFFIX		I SUFFIX		M SUFFIX		UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	
Supply voltage, $V_{CC\pm}$		±3.5	±18	±3.5	±18	±3.5	±18	V
Common-mode input voltage, V_{IC}	$V_{CC\pm}$ = ± 5 V	–1.6	4	–1.6	4	–1.6	4	V
	$V_{CC\pm}$ = ± 15 V	–11	13	–11	13	–11	13	
Operating free-air temperature, T_A		0	70	–40	85	–55	125	°C

TLE2061C electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±5 V (unless otherwise noted)

PARAMETER			TEST CONDITIONS	T_A†	TLE2061C TLE2061AC TLE2061BC			UNIT
					MIN	TYP	MAX	
V_{IO}	Input offset voltage	TLE2061C	V_{IC} = 0, R_S = 50 Ω	25°C		0.8	3.1	mV
				Full range			4	
		TLE2061AC		25°C		0.6	2.6	
				Full range			3.5	
		TLE2061BC		25°C		0.5	1.9	
				Full range			2.4	
α_{VIO}	Temperature coefficient of input offset voltage			Full range		6		μV/°C
	Input offset voltage long-term drift (see Note 4)			25°C		0.04		μV/mo
I_{IO}	Input offset current			25°C		1		pA
				Full range			0.8	nA
I_{IB}	Input bias current			25°C		3		pA
				Full range			2	nA
V_{ICR}	Common-mode input voltage range			25°C	−1.6 to 4	−2 to 6		V
				Full range	−1.6 to 4			V
V_{OM+}	Maximum positive peak output voltage swing		R_L = 10 kΩ	25°C	3.5	3.7		V
				Full range	3.3			
			R_L = 100 Ω	25°C	2.5	3.1		
				Full range	2			
V_{OM-}	Maximum negative peak output voltage swing		R_L = 10 kΩ	25°C	−3.7	−3.9		V
				Full range	−3.3			
			R_L = 100 Ω	25°C	−2.5	−2.7		
				Full range	−2			
A_{VD}	Large-signal differential voltage amplification		V_O = ±2.8 V, R_L = 10 kΩ	25°C	15	80		V/mV
				Full range	2			
			V_O = 0 to 2 V, R_L = 100 Ω	25°C	0.75	45		
				Full range	0.5			
			V_O = 0 to −2 V, R_L = 100 Ω	25°C	0.5	3		
				Full range	0.25			
r_i	Input resistance			25°C		10^{12}		Ω
c_i	Input capacitance			25°C		4		pF
z_o	Open-loop output impedance		I_O = 0	25°C		280		Ω
CMRR	Common-mode rejection ratio		V_{IC} = V_{ICR}min, R_S = 50 Ω	25°C	65	82		dB
				Full range	65			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)		$V_{CC\pm}$ = ±5 V to ±15 V, R_S = 50 Ω	25°C	75	93		dB
				Full range	75			

† Full range is 0°C to 70°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2061C electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±5 V (unless otherwise noted) (continued)

PARAMETER		TEST CONDITIONS	T_A†	TLE2061C TLE2061AC TLE2061BC			UNIT
				MIN	TYP	MAX	
I_{CC}	Supply current	V_O = 0, No load	25°C		280	325	μA
			Full range			350	
ΔI_{CC}	Supply-current change over operating temperature range		Full range		29		μA

† Full range is 0°C to 70°C.

TLE2061C operating characteristics at specified free-air temperature, $V_{CC\pm}$ = ±5 V

PARAMETER		TEST CONDITIONS	T_A†	TLE2061C TLE2061AC TLE2061BC			UNIT
				MIN	TYP	MAX	
SR	Slew rate at unity gain (see Figure 1)	R_L = 10 kΩ, C_L = 100 pF	25°C	2.2	3.4		V/μs
			Full range	2.1			
V_n	Equivalent input noise voltage (see Figure 2)	f = 10 Hz, R_S = 20 Ω	25°C		59	100	nV/√Hz
		f = 1 kHz, R_S = 20 Ω			43	60	
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 Hz to 10 Hz	25°C		1.1		μV
I_n	Equivalent input noise current	f = 1 kHz	25°C		1		fA/√Hz
THD	Total harmonic distortion	A_{VD} = 2, f = 10 kHz, $V_{O(PP)}$ = 2 V, R_L = 10 kΩ	25°C		0.025%		
B_1	Unity-gain bandwidth (see Figure 3)	R_L = 10 kΩ, C_L = 100 pF	25°C		1.8		MHz
		R_L = 100 Ω, C_L = 100 pF			1.3		
t_s	Settling time	0.1%	25°C		5		μs
		0.01%			10		
B_{OM}	Maximum output-swing bandwidth	A_{VD} = 1, R_L = 10 kΩ	25°C		140		kHz
ϕ_m	Phase margin at unity gain (see Figure 3)	R_L = 10 kΩ, C_L = 100 pF	25°C		58°		
		R_L = 100 Ω, C_L = 100 pF			75°		

† Full range is 0°C to 70°C.

TLE2061C electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±15 V (unless otherwise noted)

PARAMETER			TEST CONDITIONS	T_A†	TLE2061C TLE2061AC TLE2061BC			UNIT
					MIN	TYP	MAX	
V_{IO}	Input offset voltage	TLE2061C	V_{IC} = 0, R_S = 50 kΩ	25°C		0.6	3	mV
				Full range			3.9	
		TLE2061AC		25°C		0.5	1.5	
				Full range			2.5	
		TLE2061BC		25°C		0.3	0.5	
				Full range			1	
α_{VIO}	Temperature coefficient of input offset voltage			Full range		6		μV/°C
	Input offset voltage long-term drift (see Note 4)			25°C		0.04		μV/mo
I_{IO}	Input offset current			25°C		2		pA
				Full range			1	nA
I_{IB}	Input bias current			25°C		4		pA
				Full range			3	nA
V_{ICR}	Common-mode input voltage range			25°C	−11 to 13	−12 to 16		V
				Full range	−11 to 13			V
V_{OM+}	Maximum positive peak output voltage swing		R_L = 10 kΩ	25°C	13.2	13.7		V
				Full range	13			
			R_L = 600 Ω	25°C	12.5	13.2		
				Full range	12			
V_{OM-}	Maximum negative peak output voltage swing		R_L = 10 kΩ	25°C	−13.2	−13.7		V
				Full range	−13			
			R_L = 600 Ω	25°C	−12.5	−13		
				Full range	−12			
A_{VD}	Large-signal differential voltage amplification		V_O = ±10 V, R_L = 10 kΩ	25°C	30	230		V/mV
				Full range	20			
			V_O = 0 to 8 V, R_L = 600 Ω	25°C	25	100		
				Full range	10			
			V_O = 0 to −8 V, R_L = 600 Ω	25°C	3	25		
				Full range	1			
r_i	Input resistance			25°C		10^{12}		Ω
c_i	Input capacitance			25°C		4		pF
z_o	Open-loop output impedance		I_O = 0	25°C		280		Ω
CMRR	Common-mode rejection ratio		V_{IC} = V_{ICR}min, R_S = 50 Ω	25°C	72	90		dB
				Full range	70			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)		$V_{CC\pm}$ = ±5 V to ±15 V, R_S = 50 Ω	25°C	75	93		dB
				Full range	75			

† Full range is 0°C to 70°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2061C electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±15 V (unless otherwise noted) (continued)

PARAMETER		TEST CONDITIONS	T_A†	TLE2061C TLE2061AC TLE2061BC			UNIT
				MIN	TYP	MAX	
I_{CC}	Supply current	V_O = 0, No load	25°C		290	350	μA
			Full range			375	
ΔI_{CC}	Supply-current change over operating temperature range		Full range		34		μA

† Full range is 0°C to 70°C.

TLE2061C operating characteristics at specified free-air temperature, $V_{CC\pm}$ = ±15 V

PARAMETER		TEST CONDITIONS		T_A†	TLE2061C TLE2061AC TLE2061BC			UNIT
					MIN	TYP	MAX	
SR	Slew rate at unity gain (see Figure 1)	R_L = 10 kΩ,	C_L = 100 pF	25°C	2.6	3.4		V/μs
				Full range	2.5			
V_n	Equivalent input noise voltage (see Figure 2)	f = 10 Hz,	R_S = 20 Ω	25°C		70	100	nV/√Hz
		f = 1 kHz ,	R_S = 20 Ω			40	60	
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 Hz to 10 Hz		25°C		1.1		μV
I_n	Equivalent input noise current	f = 1 kHz		25°C		1.1		fA/√Hz
THD	Total harmonic distortion	A_{VD} = 2, $V_{O(PP)}$ = 2 V,	f = 10 kHz, R_L = 10 kΩ	25°C		0.025%		
B_1	Unity-gain bandwidth (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF	25°C		2		MHz
		R_L = 600 Ω,	C_L = 100 pF			1.5		
t_s	Settling time	0.1%		25°C		5		μs
		0.01%				10		
B_{OM}	Maximum output-swing bandwidth	A_{VD} = 1,	R_L = 10 kΩ	25°C		40		kHz
ϕ_m	Phase margin at unity gain (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF	25°C		60°		
		R_L = 600 Ω,	C_L = 100 pF			70°		

† Full range is 0°C to 70°C.

TLE2061I electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±5 V (unless otherwise noted)

PARAMETER			TEST CONDITIONS	T_A†	TLE2061I, TLE2061AI TLE2061BI			UNIT
					MIN	TYP	MAX	
V_{IO}	Input offset voltage	TLE2061I	V_{IC} = 0, R_S = 50 Ω	25°C		0.8	3.1	mV
				Full range			4.4	
		TLE2061AI		25°C		0.6	2.6	
				Full range			3.9	
		TLE2061BI		25°C		0.5	1.9	
				Full range			2.7	
α_{VIO}	Temperature coefficient of input offset voltage			Full range		6		μV/°C
	Input offset voltage long-term drift (see Note 4)			25°C		0.04		μV/mo
I_{IO}	Input offset current			25°C		1		pA
				Full range			2	nA
I_{IB}	Input bias current			25°C		3		pA
				Full range			4	nA
V_{ICR}	Common-mode input voltage range			25°C	–1.6 to 4	–2 to 6		V
				Full range	–1.6 to 4			V
V_{OM+}	Maximum positive peak output voltage swing		R_L = 10 kΩ	25°C	3.5	3.7		V
				Full range	3.1			
			R_L = 100 Ω	25°C	2.5	3.1		
				Full range	2			
V_{OM-}	Maximum negative peak output voltage swing		R_L = 10 kΩ	25°C	–3.7	–3.9		V
				Full range	–3.1			
			R_L = 100 Ω	25°C	–2.5	–2.7		
				Full range	–2			
A_{VD}	Large-signal differential voltage amplification		V_O = ±2.8 V, R_L = 10 kΩ	25°C	15	80		V/mV
				Full range	2			
			V_O = 0 to 2 V, R_L = 100 Ω	25°C	0.75	45		
				Full range	0.5			
			V_O = 0 to –2 V, R_L = 100 Ω	25°C	0.5	3		
				Full range	0.25			
r_i	Input resistance			25°C		10^{12}		Ω
c_i	Input capacitance			25°C		4		pF
z_o	Open-loop output impedance		I_O = 0	25°C		280		Ω
CMRR	Common-mode rejection ratio		V_{IC} = V_{ICR}min, R_S = 50 Ω	25°C	65	82		dB
				Full range	65			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)		$V_{CC\pm}$ = ±5 V to ±15 V, R_S = 50 Ω	25°C	75	93		dB
				Full range	65			
I_{CC}	Supply current		V_O = 0, No load	25°C		280	325	μA
				Full range			350	
ΔI_{CC}	Supply-current change over operating temperature range			Full range		29		μA

† Full range is –40°C to 85°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2061I operating characteristics at specified free-air temperature, $V_{CC\pm}$ = ±5 V

PARAMETER		TEST CONDITIONS		T_A†	TLE2061I TLE2061AI TLE2061BI			UNIT
					MIN	TYP	MAX	
SR	Slew rate at unity gain (see Figure 1)	R_L = 10 kΩ,	C_L = 100 pF	25°C	2.2	3.4		V/μs
				Full range	1.7			
V_n	Equivalent input noise voltage (see Figure 2)	f = 10 Hz,	R_S = 20 Ω	25°C		59	100	nV/√Hz
		f = 1 kHz,	R_S = 20 Ω			43	60	
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 Hz to 10 Hz		25°C		1.1		μV
I_n	Equivalent input noise current	f = 1 kHz		25°C		1		fA/√Hz
THD	Total harmonic distortion	A_{VD} = 2, $V_{O(PP)}$ = 2 V,	f = 10 kHz, R_L = 10 kΩ	25°C		0.025%		
B_1	Unity-gain bandwidth (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF	25°C		1.8		MHz
		R_L = 100 Ω,	C_L = 100 pF			1.3		
t_s	Settling time	0.1%		25°C		5		μs
		0.01%				10		
B_{OM}	Maximum output-swing bandwidth	A_{VD} = 1,	R_L = 10 kΩ	25°C		140		kHz
ϕ_m	Phase margin at unity gain (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF	25°C		58°		
		R_L = 100 Ω,	C_L = 100 pF			75°		

† Full range is –40°C to 85°C.

TLE2061I electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±15 V (unless otherwise noted)

PARAMETER			TEST CONDITIONS	T_A†	TLE2061I, TLE2061AI TLE2061BI			UNIT
					MIN	TYP	MAX	
V_{IO}	Input offset voltage	TLE2061I	V_{IC} = 0, R_S = 50 Ω	25°C		0.6	3	mV
				Full range			4.3	
		TLE2061AI		25°C		0.5	1.5	
				Full range			2.9	
		TLE2061BI		25°C		0.3	0.5	
				Full range			1.3	
α_{VIO}	Temperature coefficient of input offset voltage			Full range		6		μV/°C
	Input offset voltage long-term drift (see Note 4)			25°C		0.04		μV/mo
I_{IO}	Input offset current			25°C		2		pA
				Full range			3	nA
I_{IB}	Input bias current			25°C		4		pA
				Full range			5	nA
V_{ICR}	Common-mode input voltage range			25°C	–11 to 13	–12 to 16		V
				Full range	–11 to 13			V
V_{OM+}	Maximum positive peak output voltage swing		R_L = 10 kΩ	25°C	13.2	13.7		V
				Full range	13			
			R_L = 600 Ω	25°C	12.5	13.2		
				Full range	12			
V_{OM-}	Maximum negative peak output voltage swing		R_L = 10 kΩ	25°C	–13.2	–13.7		V
				Full range	–13			
			R_L = 600 Ω	25°C	–12.5	–13		
				Full range	–12			
A_{VD}	Large-signal differential voltage amplification		V_O = ±10 V, R_L = 10 kΩ	25°C	30	230		V/mV
				Full range	20			
			V_O = 0 to 8 V, R_L = 600 Ω	25°C	25	100		
				Full range	10			
			V_O = 0 to –8 V, R_L = 600 Ω	25°C	3	25		
				Full range	01			
r_i	Input resistance			25°C		10^{12}		Ω
c_i	Input capacitance			25°C		4		pF
z_o	Open-loop output impedance		I_O = 0	25°C		280		Ω
CMRR	Common-mode rejection ratio		V_{IC} = V_{ICR}min, R_S = 50 Ω	25°C	72	90		dB
				Full range	65			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)		$V_{CC\pm}$ = ±5 V to ±15 V, R_S = 50 Ω	25°C	75	93		dB
				Full range	65			
I_{CC}	Supply current		V_O = 0, No load	25°C		290	350	μA
				Full range			375	
ΔI_{CC}	Supply-current change over operating temperature range			Full range		34		μA

† Full range is –40°C to 85°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2061I operating characteristics at specified free-air temperature, $V_{CC\pm}$ = ±15 V

PARAMETER		TEST CONDITIONS		T_A†	TLE2061I TLE2061AI TLE2061BI			UNIT
					MIN	TYP	MAX	
SR	Slew rate at unity gain (see Figure 1)	R_L = 10 kΩ,	C_L = 100 pF	25°C	2.6	3.4		V/μs
				Full range	2.1			
V_n	Equivalent input noise voltage (see Figure 2)	f = 10 Hz,	R_S = 20 Ω	25°C		70	100	nV/√Hz
		f = 1 kHz ,	R_S = 20 Ω			40	60	
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 Hz to 10 Hz		25°C		1.1		μV
I_n	Equivalent input noise current	f = 1 kHz		25°C		1.1		fA/√Hz
THD	Total harmonic distortion	A_{VD} = 2, $V_{O(PP)}$ = 2 V,	f = 10 kHz, R_L = 10 kΩ	25°C		0.025%		
B_1	Unity-gain bandwidth (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF	25°C		2		MHz
		R_L = 600 Ω,	C_L = 100 pF			1.5		
t_s	Settling time	0.1%		25°C		5		μs
		0.01%				10		
B_{OM}	Maximum output-swing bandwidth	A_{VD} = 1,	R_L = 10 kΩ	25°C		40		kHz
ϕ_m	Phase margin at unity gain (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF	25°C		60°		
		R_L = 600 Ω,	C_L = 100 pF			70°		

† Full range is –40°C to 85°C.

TLE2061M electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±5 V (unless otherwise noted)

PARAMETER			TEST CONDITIONS	T_A†	TLE2061M TLE2061AM TLE2061BM			UNIT
					MIN	TYP	MAX	
V_{IO}	Input offset voltage	TLE2061M	V_{IC} = 0, R_S = 50 Ω	25°C		0.8	3.1	mV
				Full range			6	
		TLE2061AM		25°C		0.6	2.6	
				Full range			4.6	
		TLE2061BM		25°C		0.5	1.9	
				Full range			3.1	
α_{VIO}	Temperature coefficient of input offset voltage			Full range		6		μV/°C
	Input offset voltage long-term drift (see Note 4)			25°C		0.04		μV/mo
I_{IO}	Input offset current			25°C		1		pA
				Full range			15	nA
I_{IB}	Input bias current			25°C		3		pA
				Full range			30	nA
V_{ICR}	Common-mode input voltage range			25°C	–1.6 to 4	–2 to 6		V
				Full range	–1.6 to 4			V
V_{OM+}	Maximum positive peak output voltage swing		R_L = 10 kΩ	25°C	3.5	3.7		V
				Full range	3			
			R_L = 600 Ω	25°C	2.5	3.6		
				Full range	2			
			R_L = 100 Ω	25°C	2.5	3.1		
				Full range	2			
V_{OM-}	Maximum negative peak output voltage swing		R_L = 10 kΩ	25°C	–3.5	–3.9		V
				Full range	–3			
		FK and JG packages	R_L = 600 Ω	25°C	–2.5	–3.5		
				Full range	–2			
		D and P packages	R_L = 100 Ω	25°C	–2.5	–2.7		
				Full range	–2			
A_{VD}	Large-signal differential voltage amplification		V_O = ±2.8 V, R_L = 10 kΩ	25°C	15	80		V/mV
				Full range	2			
		FK and JG packages	V_O = 0 to 2.5 V, R_L = 600 Ω	25°C	1	65		
				Full range	0.5			
			V_O = 0 to –2.5 V, R_L = 600 Ω	25°C	1	16		
				Full range	0.5			
		D and P packages	V_O = 0 to 2 V, R_L = 100 Ω	25°C	0.75	45		
				Full range	0.5			
			V_O = 0 to –2 V, R_L = 100 Ω	25°C	0.5	3		
				Full range	0.25			

† Full range is –55°C to 125°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2061M electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±5 V (unless otherwise noted) (continued)

PARAMETER		TEST CONDITIONS	T_A†	TLE2061M TLE2061AM TLE2061BM			UNIT
				MIN	TYP	MAX	
r_i	Input resistance		25°C		10^{12}		Ω
c_i	Input capacitance		25°C		4		pF
z_o	Open-loop output impedance	I_O = 0	25°C		280		Ω
CMRR	Common-mode rejection ratio	V_{IC} = V_{ICR}min, R_S = 50 Ω	25°C	65	82		dB
			Full range	60			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)	$V_{CC\pm}$ = ±5 V to ±15 V, R_S = 50 Ω	25°C	75	93		dB
			Full range	65			
I_{CC}	Supply current	V_O = 0, No load	25°C		280	325	μA
			Full range			350	
ΔI_{CC}	Supply-current change over operating temperature range	V_O = 0, No load	Full range		39		μA

† Full range is –55°C to 125°C.

TLE2061M operating characteristics at specified free-air temperature, $V_{CC\pm}$ = ±5 V, T_A = 25°C

PARAMETER		TEST CONDITIONS		TLE2061M TLE2061AM TLE2061BM			UNIT
				MIN	TYP	MAX	
SR	Slew rate at unity gain (see Figure 1)	R_L = 10 kΩ,	C_L = 100 pF		3.4		V/μs
V_n	Equivalent input noise voltage (see Figure 2)	f = 10 Hz,	R_S = 20 Ω		59		nV/√Hz
		f = 1 kHz,	R_S = 20 Ω		43		
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 Hz to 10 Hz			1.1		μV
I_n	Equivalent input noise current	f = 1 kHz			1		fA/√Hz
THD	Total harmonic distortion	A_{VD} = 2, $V_{O(PP)}$ = 2 V,	f = 10 kHz, R_L = 10 kΩ		0.025%		
B_1	Unity-gain bandwidth (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF		1.8		MHz
		R_L = 600 Ω,	C_L = 100 pF		1.3		
t_s	Settling time	0.1%			5		μs
		0.01%			10		
B_{OM}	Maximum output-swing bandwidth	A_{VD} = 1,	R_L = 10 kΩ		140		kHz
ϕ_m	Phase margin at unity gain (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF		58°		
		R_L = 600 Ω,	C_L = 100 pF		75°		

TLE2061M electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±15 V (unless otherwise noted)

PARAMETER			TEST CONDITIONS	T_A†	TLE2061M ,TLE2061AM TLE2061BM			UNIT
					MIN	TYP	MAX	
V_{IO}	Input offset voltage	TLE2061M	V_{IC} = 0, R_S = 50 Ω	25°C		0.6	3	mV
				Full range			6	
		TLE2061AM		25°C		0.5	1.5	
				Full range			3.6	
		TLE2061BM		25°C		0.3	0.5	
				Full range			1.7	
α_{VIO}	Temperature coefficient of input offset voltage			Full range		6		μV/°C
	Input offset voltage long-term drift (see Note 4)			25°C		0.04		μV/mo
I_{IO}	Input offset current			25°C		2		pA
				Full range			20	nA
I_{IB}	Input bias current			25°C		4		pA
				Full range			40	nA
V_{ICR}	Common-mode input voltage range			25°C	–11 to 13	–12 to 16		V
				Full range	–11 to 13			V
V_{OM+}	Maximum positive peak output voltage swing		R_L = 10 kΩ	25°C	13	13.7		V
				Full range	12.5			
			R_L = 600 Ω	25°C	12.5	13.2		
				Full range	12			
V_{OM-}	Maximum negative peak output voltage swing		R_L = 10 kΩ	25°C	–13	–13.7		V
				Full range	–12.5			
			R_L = 600 Ω	25°C	–12.5	–13		
				Full range	–12			
A_{VD}	Large-signal differential voltage amplification		V_O = ±10 V, R_L = 10 kΩ	25°C	30	230		V/mV
				Full range	20			
			V_O = 0 to 8 V, R_L = 600 Ω	25°C	25	100		
				Full range	7			
			V_O = 0 to – 8 V, R_L = 600 Ω	25°C	3	25		
				Full range	1			
r_i	Input resistance			25°C		10^{12}		Ω
c_i	Input capacitance			25°C		4		pF
z_o	Open-loop output impedance		I_O = 0	25°C		280		Ω
CMRR	Common-mode rejection ratio		V_{IC} = V_{ICR}min, R_S = 50 Ω	25°C	72	90		dB
				Full range	65			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)		$V_{CC\pm}$ = ±5 V to ±15 V, R_S = 50 Ω	25°C	75	93		dB
				Full range	65			

† Full range is –55°C to 125°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2061M electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±15 V (unless otherwise noted) (continue)

PARAMETER		TEST CONDITIONS	T_A†	TLE2061M ,TLE2061AM TLE2061BM			UNIT
				MIN	TYP	MAX	
I_{CC}	Supply current	V_O = 0, No load	25°C		290	350	μA
			Full range			375	
ΔI_{CC}	Supply-current change over operating temperature range		Full range		46		μA

† Full range is –55°C to 125°C.

TLE2061M operating characteristics at specified free-air temperature, $V_{CC\pm}$ = ±15 V

PARAMETER		TEST CONDITIONS		T_A†	TLE2061M TLE2061AM TLE2061BM			UNIT
					MIN	TYP	MAX	
SR	Slew rate at unity gain (see Figure 1)	R_L = 10 kΩ,	C_L = 100 pF	25°C	2	3.4		V/μs
				Full range	1.8			
V_n	Equivalent input noise voltage (see Figure 2)	f = 10 Hz,	R_S = 20 Ω	25°C		70		nV/√Hz
		f = 1 kHz,	R_S = 20 Ω	25°C		40		
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 Hz to 10 Hz		25°C		1.1		μV
I_n	Equivalent input noise current	f = 1 kHz		25°C		1.1		fA/√Hz
THD	Total harmonic distortion	A_{VD} = 2, $V_{O(PP)}$ = 2 V,	f = 10 kHz, R_L = 10 kΩ	25°C		0.025%		
B_1	Unity-gain bandwidth (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF	25°C		2		MHz
		R_L = 600 Ω,	C_L = 100 pF	25°C		1.5		
t_s	Settling time	0.1%		25°C		5		μs
		0.01%		25°C		10		
B_{OM}	Maximum output-swing bandwidth	A_{VD} = 1,	R_L = 10 kΩ	25°C		40		kHz
ϕ_m	Phase margin at unity gain (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF	25°C		60°		
		R_L = 600 Ω,	C_L = 100 pF	25°C		70°		

† Full range is –55°C to 125°C.

TLE2061Y electrical characteristics at $V_{CC\pm}$ = ±15 V, T_A = 25°C (unless otherwise noted)

PARAMETER		TEST CONDITIONS		TLE2061Y			UNIT
				MIN	TYP	MAX	
V_{IO}	Input offset voltage	V_{IC} = 0,	R_S = 50 Ω		0.6	3	mV
α_{VIO}	Input offset voltage long-term drift (see Note 4)				0.04		μV/mo
I_{IO}	Input offset current				2		pA
I_{IB}	Input bias current				4		pA
V_{ICR}	Common-mode input voltage range			–11 to 13	–12 to 16		V
V_{OM+}	Maximum positive peak output voltage swing	R_L = 10 kΩ		13.2	13.7		V
		R_L = 600 Ω		12.5	13.2		
V_{OM-}	Maximum negative peak output voltage swing	R_L = 10 kΩ		–13.2	–13.7		V
		R_L = 600 Ω		–12.5	– 13		
A_{VD}	Large-signal differential voltage amplification	V_O = ±10 V,	R_L = 10 kΩ	30	230		V/mV
		V_O = 0 to 8 V,	R_L = 600 Ω	25	100		
		V_O = 0 to – 8 V,	R_L = 600 Ω	3	25		
r_i	Input resistance				10^{12}		Ω
c_i	Input capacitance				4		pF
z_o	Open-loop output impedance	I_O = 0			280		Ω
CMRR	Common-mode rejection ratio	R_S = 50 Ω,	V_{IC} = V_{ICR}min	72	90		dB
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC}/\Delta V_{IO}$)	$V_{CC\pm}$ = ±5 V to ±15 V, R_S = 50 Ω		75	93		dB
I_{CC}	Supply current	V_O = 0,	No load		290	350	μA

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2061Y operating characteristics at $V_{CC\pm}$ = ±15 V, T_A = 25°C

PARAMETER		TEST CONDITIONS		TLE2061Y			UNIT
				MIN	TYP	MAX	
SR	Slew rate at unity gain (see Figure 1)	R_L = 10 kΩ,	C_L = 100 pF	2.6	3.4		V/μs
V_n	Equivalent input noise voltage (see Figure 2)	f = 10 Hz,	R_S = 20 Ω		70		nV/√Hz
		f = 1 kHz,	R_S = 20 Ω		40		
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 Hz to 10 Hz			1.1		μV
I_n	Equivalent input noise current	f = 1 Hz			1.1		fA/√Hz
THD	Total harmonic distortion	A_{VD} = 2, $V_{O(PP)}$ = 2 V,	f = 10 kHz, R_L = 10 kΩ		0.025%		
B_1	Unity-gain bandwidth (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF		2		MHz
		R_L = 600 Ω,	C_L = 100 pF		1.5		
t_s	Settling time	0.1%			5		μs
		0.01%			10		
B_{OM}	Maximum output-swing bandwidth	A_{VD} = 1,	R_L = 10 kΩ		40		kHz
ϕ_m	Phase margin at unity gain (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF		60°		
		R_L = 600 Ω,	C_L = 100 pF		70°		

TLE2062C electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±5 V (unless otherwise noted)

PARAMETER			TEST CONDITIONS	T_A†	TLE2062C TLE2062AC TLE2062BC			UNIT
					MIN	TYP	MAX	
V_{IO}	Input offset voltage	TLE2062C	V_{IC} = 0, R_S = 50 Ω	25°C		1	5	mV
				Full range			5.9	
		TLE2062AC		25°C		0.9	4	
				Full range			4.9	
		TLE2062BC		25°C		0.7	3	
				Full range			3.9	
α_{VIO}	Temperature coefficient of input offset voltage			Full range		6		μV/°C
	Input offset voltage long-term drift (see Note 4)			25°C		0.04		μV/mo
I_{IO}	Input offset current			25°C		1		pA
				Full range			0.8	nA
I_{IB}	Input bias current			25°C		3		pA
				Full range			2	nA
V_{ICR}	Common-mode input voltage range			25°C	−1.6 to 4	−2 to 6		V
				Full range	−1.6 to 4			V
V_{OM+}	Maximum positive peak output voltage swing		R_L = 10 kΩ	25°C	3.5	3.7		V
				Full range	3.3			
			R_L = 100 Ω	25°C	2.5	3.1		
				Full range	2			
V_{OM-}	Maximum negative peak output voltage swing		R_L = 10 kΩ	25°C	−3.7	−3.9		V
				Full range	−3.3			
			R_L = 100 Ω	25°C	−2.5	−2.7		
				Full range	−2			
A_{VD}	Large-signal differential voltage amplification		V_O = ± 2.8 V, R_L = 10 kΩ	25°C	15	80		V/mV
				Full range	2			
			V_O = 0 to 2 V, R_L = 100 Ω	25°C	0.75	45		
				Full range	0.5			
			V_O = 0 to −2 V, R_L = 100 Ω	25°C	0.5	3		
				Full range	0.25			
r_i	Input resistance			25°C		10^{12}		Ω
c_i	Input capacitance			25°C		4		pF
z_o	Open-loop output impedance		I_O = 0	25°C		560		Ω
CMRR	Common-mode rejection ratio		V_{IC} = V_{ICR}min, R_S = 50 Ω	25°C	65	82		dB
				Full range	65			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)		$V_{CC\pm}$ = ± 5 V to ± 15 V, R_S = 50 Ω	25°C	75	93		dB
				Full range	75			

† Full range is 0°C to 70°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150 °C extrapolated to T_A = 25 °C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2062C electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±5 V (unless otherwise noted) (continued)

PARAMETER		TEST CONDITIONS	T_A†	TLE2062C TLE2062AC TLE2062BC			UNIT
				MIN	TYP	MAX	
I_{CC}	Supply current	V_O = 0, No load	25°C		560	620	μA
			Full range			635	
ΔI_{CC}	Supply-current change over operating temperature range		Full range		26		μA

† Full range is 0°C to 70°C.

TLE2062C operating characteristics at specified free-air temperature, $V_{CC\pm}$ = ±5 V

PARAMETER		TEST CONDITIONS		T_A†	TLE2062C TLE2062AC TLE2062BC			UNIT
					MIN	TYP	MAX	
SR	Slew rate at unity gain (see Figure 1)	R_L = 10 kΩ,	C_L = 100 pF	25°C	2.2	3.4		V/μs
				Full range	2.1			
V_n	Equivalent input noise voltage (see Figure 2)	f = 10 Hz,	R_S = 20 Ω	25°C		59	100	nV/√Hz
		f = 1 kHz,	R_S = 20 Ω	25°C		43	60	
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 Hz to 10 Hz		25°C		1.1		μV
I_n	Equivalent input noise current	f = 1 kHz		25°C		1		fA/√Hz
THD	Total harmonic distortion	$V_{O(PP)}$ = 2 V, A_{VD} = 2,	R_L = 10 kΩ, f = 10 kHz	25°C		0.025%		
B_1	Unity-gain bandwidth (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF	25°C		1.8		MHz
		R_L = 100 Ω,	C_L = 100 pF	25°C		1.3		
	Settling time	0.1%		25°C		5		μs
		0.01%		25°C		10		
B_{OM}	Maximum output-swing bandwidth	A_{VD} = 1,	R_L = 10 kΩ	25°C		140		kHz
ϕ_m	Phase margin at unity gain (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF	25°C		58°		
		R_L = 100 Ω,	C_L = 100 pF	25°C		75°		

† Full range is 0°C to 70°C.

TLE2062C electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±15 V (unless otherwise noted)

PARAMETER			TEST CONDITIONS	T_A†	TLE2062C TLE2062AC TLE2062BC			UNIT
					MIN	TYP	MAX	
V_{IO}	Input offset voltage	TLE2062C	V_{IC} = 0, R_S = 50 Ω	25°C		0.9	4	mV
				Full range			4.9	
		TLE2062AC		25°C		0.8	2	
				Full range			2.9	
		TLE2062BC		25°C		0.5	1	
				Full range			1.9	
α_{VIO}	Temperature coefficient of input offset voltage			Full range		6		μV/°C
	Input offset voltage long-term drift (see Note 4)			25°C		0.04		μV/mo
I_{IO}	Input offset current			25°C		2		pA
				Full range			1	nA
I_{IB}	Input bias current			25°C		4		pA
				Full range			3	nA
V_{ICR}	Common-mode input voltage range			25°C	−11 to 13	−12 to 16		V
				Full range	−11 to 13			V
V_{OM+}	Maximum positive peak output voltage swing		R_L = 10 kΩ	25°C	13.2	13.7		V
				Full range	13			
			R_L = 600 Ω	25°C	12.5	13.2		
				Full range	12			
V_{OM-}	Maximum negative peak output voltage swing		R_L = 10 kΩ	25°C	−13.2	−13.7		V
				Full range	−13			
			R_L = 600 Ω	25°C	−12.5	−13		
				Full range	−12			
A_{VD}	Large-signal differential voltage amplification		V_O = ± 10 V, R_L = 10 kΩ	25°C	30	230		V/mV
				Full range	20			
			V_O = 0 to 8 V, R_L = 600 Ω	25°C	25	100		
				Full range	10			
			V_O = 0 to −8 V, R_L = 600 Ω	25°C	3	25		
				Full range	1			
r_i	Input resistance			25°C		10^{12}		Ω
c_i	Input capacitance			25°C		4		pF
z_o	Open-loop output impedance		I_O = 0	25°C		560		Ω
CMRR	Common-mode rejection ratio		V_{IC} = V_{ICR}min, R_S = 50 Ω	25°C	72	90		dB
				Full range	70			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)		$V_{CC\pm}$ = ± 5 V to ± 15 V, R_S = 50 Ω	25°C	75	93		dB
				Full range	75			

† Full range is 0°C to 70°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150 °C extrapolated to T_A = 25 °C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2062C electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±15 V (unless otherwise noted) (continued)

PARAMETER		TEST CONDITIONS	T_A†	TLE2062C TLE2062AC TLE2062BC			UNIT
				MIN	TYP	MAX	
I_{CC}	Supply current	V_O = 0 V, No load	25°C		625	690	μA
			Full range			715	
ΔI_{CC}	Supply-current change over operating temperature range		Full range		36		μA

† Full range is 0°C to 70°C.

TLE2062C operating characteristics at specified free-air temperature, $V_{CC\pm}$ = ±15 V

PARAMETER		TEST CONDITIONS	T_A†	TLE2062C TLE2062AC TLE2062BC			UNIT
				MIN	TYP	MAX	
SR	Slew rate at unity gain (see Figure 1)	R_L = 10 kΩ, C_L = 100 pF	25°C	2.6	3.4		V/μs
			Full range	2.5			
V_n	Equivalent input noise voltage (see Figure 2)	f = 10 Hz, R_S = 20 Ω	25°C		70	100	nV/√Hz
		f = 1 kHz, R_S = 20 Ω	25°C		40	60	
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 Hz to 10 Hz	25°C		1.1		μV
I_n	Equivalent input noise current	f = 1 kHz	25°C		1.1		fA/√Hz
THD	Total harmonic distortion	$V_{O(PP)}$ = 2 V, R_L = 10 kΩ, A_{VD} = 2, f = 10 kHz	25°C		0.025%		
B_1	Unity-gain bandwidth (see Figure 3)	R_L = 10 kΩ, C_L = 10 0 pF	25°C		2		MHz
		R_L = 600 Ω, C_L = 100 pF	25°C		1.5		
	Settling time	0.1%	25°C		5		μs
		0.01%	25°C		10		
B_{OM}	Maximum output-swing bandwidth	A_{VD} = 1, R_L = 10 kΩ	25°C		40		kHz
ϕ_m	Phase margin at unity gain (see Figure 3)	R_L = 10 kΩ, C_L = 100 pF	25°C		60°		
		R_L = 600 Ω, C_L = 100 pF	25°C		70°		

† Full range is 0°C to 70°C.

TLE2062I electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±5 V (unless otherwise noted)

PARAMETER			TEST CONDITIONS	T_A†	TLE2062I TLE2062AI TLE2062BI			UNIT
					MIN	TYP	MAX	
V_{IO}	Input offset voltage	TLE2062I	V_{IC} = 0, R_S = 50 Ω	25°C		1	5	mV
				Full range			6.3	
		TLE2062AI		25°C		0.9	4	
				Full range			5.3	
		TLE2062BI		25°C		0.7	3	
				Full range			4.3	
α_{VIO}	Temperature coefficient of input offset voltage			Full range		6		μV/°C
	Input offset voltage long-term drift (see Note 4)			25°C		0.04		μV/mo
I_{IO}	Input offset current			25°C		1		pA
				Full range			2	nA
I_{IB}	Input bias current			25°C		3		pA
				Full range			4	nA
V_{ICR}	Common-mode input voltage range			25°C	−1.6 to 4	−2 to 6		V
				Full range	−1.6 to 4			V
V_{OM+}	Maximum positive peak output voltage swing		R_L = 10 kΩ	25°C	3.5	3.7		V
				Full range	3.1			
			R_L = 100 Ω	25°C	2.5	3.1		
				Full range	2			
V_{OM-}	Maximum negative peak output voltage swing		R_L = 10 kΩ	25°C	−3.7	−3.9		V
				Full range	−3.1			
			R_L = 100 Ω	25°C	−2.5	−2.7		
				Full range	−2			
A_{VD}	Large-signal differential voltage amplification		V_O = ± 2.8 V, R_L = 10 kΩ	25°C	15	80		V/mV
				Full range	2			
			V_O = 0 to 2 V, R_L = 100 Ω	25°C	0.75	45		
				Full range	0.5			
			V_O = 0 to −2 V, R_L = 100 Ω	25°C	0.5	3		
				Full range	0.25			
r_i	Input resistance			25°C		10^{12}		Ω
c_i	Input capacitance			25°C		4		pF
z_o	Open-loop output impedance		I_O = 0	25°C		560		Ω
CMRR	Common-mode rejection ratio		V_{IC} = V_{ICR}min, R_S = 50 Ω	25°C	65	82		dB
				Full range	65			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)		$V_{CC\pm}$ = ± 5 V to ± 15 V, R_S = 50 Ω	25°C	75	93		dB
				Full range	65			

† Full range is −40°C to 85°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2062I electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±5 V (unless otherwise noted) (continued)

PARAMETER		TEST CONDITIONS	T_A†	TLE2062I TLE2062AI TLE2062BI			UNIT
				MIN	TYP	MAX	
I_{CC}	Supply current	V_O = 0, No load	25°C		560	620	μA
			Full range			640	
ΔI_{CC}	Supply-current change over operating temperature range		Full range		54		μA

† Full range is –40°C to 85°C.

TLE2062I operating characteristics at specified free-air temperature, $V_{CC\pm}$ = ±5 V

PARAMETER		TEST CONDITIONS		T_A†	TLE2062I TLE2062AI TLE2062BI			UNIT
					MIN	TYP	MAX	
SR	Slew rate at unity gain (see Figure 1)	R_L = 10 kΩ,	C_L = 100 pF	25°C	2.2	3.4		V/μs
				Full range	1.7			
V_n	Equivalent input noise voltage (see Figure 2)	f = 10 Hz,	R_S = 20 Ω	25°C		59	100	nV/√Hz
		f = 1 kHz,	R_S = 20 Ω	25°C		43	60	
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 Hz to 10 Hz		25°C		1.1		μV
I_n	Equivalent input noise current	f = 1 kHz		25°C		1		fA/√Hz
THD	Total harmonic distortion	$V_{O(PP)}$ = 2 V, A_{VD} = 2,	R_L = 10 kΩ, f = 10 kHz	25°C		0.025%		
B_1	Unity-gain bandwidth (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF	25°C		1.8		MHz
		R_L = 100 Ω,	C_L = 100 pF	25°C		1.3		
	Settling time	0.1%		25°C		5		μs
		0.01%		25°C		10		
B_{OM}	Maximum output-swing bandwidth	A_{VD} = 1,	R_L = 10 kΩ	25°C		140		kHz
ϕ_m	Phase margin at unity gain (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF	25°C		58°		
		R_L = 100 Ω,	C_L = 100 pF	25°C		75°		

† Full range is –40°C to 85°C.

TLE2062I electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±15 V (unless otherwise noted)

PARAMETER			TEST CONDITIONS	T_A†	TLE2062I TLE2062AI TLE2062BI			UNIT
					MIN	TYP	MAX	
V_{IO}	Input offset voltage	TLE2062I	V_{IC} = 0, R_S = 50 Ω	25°C		0.9	4	mV
				Full range			5.3	
		TLE2062AI		25°C		0.8	2	
				Full range			3.3	
		TLE2062BI		25°C		0.5	1	
				Full range			2.3	
α_{VIO}	Temperature coefficient of input offset voltage			Full range		6		μV/°C
	Input offset voltage long-term drift (see Note 4)			25°C		0.04		μV/mo
I_{IO}	Input offset current			25°C		2		pA
				Full range			3	nA
I_{IB}	Input bias current			25°C		4		pA
				Full range			5	nA
V_{ICR}	Common-mode input voltage range			25°C	–11 to 13	–12 to 16		V
				Full range	–11 to 13			V
V_{OM+}	Maximum positive peak output voltage swing		R_L = 10 kΩ	25°C	13.2	13.7		V
				Full range	13			
			R_L = 600 Ω	25°C	12.5	13.2		
				Full range	12			
V_{OM-}	Maximum negative peak output voltage swing		R_L = 10 kΩ	25°C	–13.2	–13.7		V
				Full range	–13			
			R_L = 600 Ω	25°C	–12.5	–13		
				Full range	–12			
A_{VD}	Large-signal differential voltage amplification		V_O = ± 10 V, R_L = 10 kΩ	25°C	30	230		V/mV
				Full range	20			
			V_O = 0 to 8 V, R_L = 600 Ω	25°C	25	100		
				Full range	10			
			V_O = 0 to –8 V, R_L = 600 Ω	25°C	3	25		
				Full range	1			
r_i	Input resistance			25°C		10^{12}		Ω
c_i	Input capacitance			25°C		4		pF
z_o	Open-loop output impedance		I_O = 0	25°C		560		Ω
CMRR	Common-mode rejection ratio		V_{IC} = V_{ICR}min, R_S = 50 Ω	25°C	72	90		dB
				Full range	65			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)		$V_{CC\pm}$ = ± 5 V to ± 15 V, R_S = 50 Ω	25°C	75	93		dB
				Full range	65			

† Full range is –40°C to 85°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2062I electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±15 V (unless otherwise noted) (continued)

PARAMETER		TEST CONDITIONS	T_A†	TLE2062I TLE2062AI TLE2062BI			UNIT
				MIN	TYP	MAX	
I_{CC}	Supply current	V_O = 0, No load	25°C		625	690	μA
			Full range			720	
ΔI_{CC}	Supply-current change over operating temperature range		Full range		74		μA

† Full range is –40°C to 85°C.

TLE2062I operating characteristics at specified free-air temperature, $V_{CC\pm}$ = ±15 V

PARAMETER		TEST CONDITIONS	T_A†	TLE2062I TLE2062AI TLE2062BI			UNIT
				MIN	TYP	MAX	
SR	Slew rate at unity gain (see Figure 1)	R_L = 10 kΩ, C_L = 100 pF	25°C	2.6	3.4		V/μs
			Full range	2.1			
V_n	Equivalent input noise voltage (see Figure 2)	f = 10 Hz, R_S = 20 Ω	25°C		70	100	nV/√Hz
		f = 1 kHz, R_S = 20 Ω	25°C		40	60	
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 Hz to 10 Hz	25°C		1.1		μV
I_n	Equivalent input noise current	f = 1 kHz	25°C		1.1		fA/√Hz
THD	Total harmonic distortion	$V_{O(PP)}$ = 2 V, R_L = 10 kΩ, A_{VD} = 2, f = 10 kHz	25°C		0.025%		
B_1	Unity-gain bandwidth (see Figure 3)	R_L = 10 kΩ, C_L = 100 pF	25°C		2		MHz
		R_L = 600 Ω, C_L = 100 pF	25°C		1.5		
	Settling time	0.1%	25°C		5		μs
		0.01%	25°C		10		
B_{OM}	Maximum output-swing bandwidth	A_{VD} = 1, R_L = 10 kΩ	25°C		40		kHz
ϕ_m	Phase margin at unity gain (see Figure 3)	R_L = 10 kΩ, C_L = 100 pF	25°C		60°		
		R_L = 600 Ω, C_L = 100 pF	25°C		70°		

† Full range is –40°C to 85°C.

TLE2062M electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±5 V

PARAMETER			TEST CONDITIONS		T_A†	TLE2062M TLE2062AM TLE2062BM			UNIT
						MIN	TYP	MAX	
V_{IO}	Input offset voltage	TLE2062M	V_{IC} = 0,	R_S = 50 Ω	25°C		1	5	mV
					Full range			7	
		TLE2062AM			25°C		0.9	4	
					Full range			6	
		TLE2062BM			25°C		0.7	3	
					Full range			5	
α_{VIO}	Temperature coefficient of input offset voltage				Full range		6		μV/°C
	Input offset voltage long-term drift (see Note 4)				25°C		0.04		μV/mo
I_{IO}	Input offset current				25°C		1		pA
					Full range			15	nA
I_{IB}	Input bias current				25°C		3		pA
					Full range			30	nA
V_{ICR}	Common-mode input voltage range				25°C	−1.6 to 4	−2 to 6		V
					Full range	−1.6 to 4			V
V_{OM+}	Maximum positive peak output voltage swing		R_L = 10 kΩ		25°C	3.5	3.7		V
					Full range	3			
		FK and JG packages	R_L = 600 Ω		25°C	2.5	3.6		
					Full range	2			
		D and P packages	R_L = 100 Ω		25°C	2.5	3.1		
					Full range	2			
V_{OM-}	Maximum negative peak output voltage swing		R_L = 10 kΩ		25°C	−3.5	−3.9		V
					Full range	−3			
		FK and JG packages	R_L = 600 Ω		25°C	−2.5	−3.5		
					Full range	−2			
		D and P packages	R_L = 100 Ω		25°C	−2.5	−2.7		
					Full range	−2			
A_{VD}	Large-signal differential voltage amplification		V_O = ±2.8 V,	R_L = 10 kΩ	25°C	15	80		V/mV
					Full range	2			
		FK and JG packages	V_O = 0 to 2.5 V,	R_L = 600 Ω	25°C	1	65		
					Full range	0.5			
			V_O = 0 to −2.5 V,	R_L = 600 Ω	25°C	1	16		
					Full range	0.5			
		D and P packages	V_O = 0 to 2 V,	R_L = 100 Ω	25°C	0.75	45		
					Full range	0.5			
			V_O = 0 to −2 V,	R_L = 100 Ω	25°C	0.5	3		
					Full range	0.25			

† Full range is −55°C to 125°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150 °C extrapolated to T_A = 25 °C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2062M electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±5 V (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A†	TLE2062M TLE2062AM TLE2062BM			UNIT
				MIN	TYP	MAX	
r_i	Input resistance		25°C		10^{12}		Ω
c_i	Input capacitance		25°C		4		pF
z_o	Open-loop output impedance	I_O = 0	25°C		560		Ω
CMRR	Common-mode rejection ratio	V_{IC} = V_{ICR}min, R_S = 50 Ω,	25°C	65	82		dB
			Full range	60			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)	$V_{CC\pm}$ = ±5 V to ±15 V, R_S = 50 Ω	25°C	75	93		dB
			Full range	65			
I_{CC}	Supply current (two amplifiers)	V_O = 0, No load	25°C		560	620	μA
			Full range			650	
ΔI_{CC}	Supply-current change over operating temperature range (two amplifiers)		Full range		72		μA

† Full range is –55°C to 125°C.

TLE2062M operating characteristics at specified free-air temperature, T_A = 25°C, $V_{CC\pm}$ = ±5 V

PARAMETER		TEST CONDITIONS		TLE2062M TLE2062AM TLE2062BM			UNIT
				MIN	TYP	MAX	
SR	Slew rate at unity gain (see Figure 1)	R_L = 10 kΩ,	C_L = 100 pF		3.4		V/μs
V_n	Equivalent input noise voltage (see Figure 2)	f = 10 Hz,	R_S = 20 Ω		59		nV/√Hz
		f = 1 kHz,	R_S = 20 Ω		43		
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 Hz to 10 Hz			1.1		μV
I_n	Equivalent input noise current	f = 1 kHz			1		fA/√Hz
THD	Total harmonic distortion	$V_{O(PP)}$ = 2 V, A_{VD} = 2,	R_L = 10 kΩ, f = 10 kHz		0.025%		
B_1	Unity-gain bandwidth (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF		1.8		MHz
		R_L = 600 Ω,	C_L = 100 pF		1.3		
	Settling time	0.1%			5		μs
		0.01%			10		
B_{OM}	Maximum output-swing bandwidth	A_{VD} = 1,	R_L = 10 kΩ		140		kHz
ϕ_m	Phase margin at unity gain (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF		58°		
		R_L = 600 Ω,	C_L = 100 pF		75°		

TLE2062M electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±15 V (unless otherwise noted)

PARAMETER			TEST CONDITIONS	T_A†	TLE2062M TLE2062AM TLE2062BM			UNIT
					MIN	TYP	MAX	
V_{IO}	Input offset voltage	TLE2062M	V_{IC} = 0, R_S = 50 Ω	25°C		0.9	4	mV
				Full range			6	
		TLE2062AM		25°C		0.8	2	
				Full range			4	
		TLE2062BM		25°C		0.5	1	
				Full range			3	
α_{VIO}	Temperature coefficient of input offset voltage			Full range		6		μV/°C
	Input offset voltage long-term drift (see Note 4)			25°C		0.04		μV/mo
I_{IO}	Input offset current			25°C		2		pA
				Full range			20	nA
I_{IB}	Input bias current			25°C		4		pA
				Full range			40	nA
V_{ICR}	Common-mode input voltage range			25°C	–11 to 13	–12 to 16		V
				Full range	–11 to 13			V
V_{OM+}	Maximum positive peak output voltage swing		R_L = 10 kΩ	25°C	13	13.7		V
				Full range	12.5			
			R_L = 600 Ω	25°C	12.5	13.2		
				Full range	11			
V_{OM-}	Maximum negative peak output voltage swing		R_L = 10 kΩ	25°C	–13	–13.7		V
				Full range	–12.5			
			R_L = 600 Ω	25°C	–12.5	–13		
				Full range	–11			
A_{VD}	Large-signal differential voltage amplification		V_O = ± 10 V, R_L = 10 kΩ	25°C	30	230		V/mV
				Full range	20			
			V_O = 0 to 8 V, R_L = 600 Ω	25°C	25	100		
				Full range	7			
			V_O = 0 to –8 V, R_L = 600 Ω	25°C	3	25		
				Full range	1			
r_i	Input resistance			25°C		10^{12}		Ω
c_i	Input capacitance			25°C		4		pF
z_o	Open-loop output impedance		I_O = 0	25°C		560		Ω
CMRR	Common-mode rejection ratio		V_{IC} = V_{ICR}min, R_S = 50 Ω	25°C	72	90		dB
				Full range	65			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)		$V_{CC\pm}$ = ± 5 V to ± 15 V, R_S = 50 Ω	25°C	75	93		dB
				Full range	65			

† Full range is –55°C to 125°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150 °C extrapolated to T_A = 25 °C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2062M electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±15 V (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T_A†	TLE2062M TLE2062AM TLE2062BM			UNIT
					MIN	TYP	MAX	
I_{CC}	Supply current	V_O = 0,	No load	25°C		625	690	μA
				Full range			730	
ΔI_{CC}	Supply-current change over operating temperature range			Full range		97		μA

† Full range is –55°C to 125°C.

TLE2062M operating characteristics at specified free-air temperature, $V_{CC\pm}$ = ±15 V

PARAMETER		TEST CONDITIONS		T_A†	TLE2062M TLE2062AM TLE2062BM			UNIT
					MIN	TYP	MAX	
SR	Slew rate at unity gain (see Figure 1)	R_L = 10 kΩ,	C_L = 100 pF	25°C	2	3.4		V/μs
				Full range	1.8			
V_n	Equivalent input noise voltage (see Figure 2)	f = 10 Hz,	R_S = 20 Ω	25°C		70		nV/√Hz
		f = 1 kHz,	R_S = 20 Ω	25°C		40		
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 Hz to 10 Hz		25°C		1.1		μV
I_n	Equivalent input noise current	f = 1 kHz		25°C		1.1		fA/√Hz
THD	Total harmonic distortion	$V_{O(PP)}$ = 2 V, A_{VD} = 2,	R_L = 10 kΩ, f = 10 kHz	25°C		0.025%		
B_1	Unity-gain bandwidth (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF	25°C		2		MHz
		R_L = 600 Ω,	C_L = 100 pF	25°C		1.5		
	Settling time	0.1%		25°C		5		μs
		0.01%		25°C		10		
B_{OM}	Maximum output-swing bandwidth	A_{VD} = 1,	R_L = 10 kΩ	25°C		40		kHz
ϕ_m	Phase margin at unity gain (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF	25°C		60°		
		R_L = 600 Ω,	C_L = 100 pF	25°C		70°		

† Full range is –55°C to 125°C.

TLE2062Y electrical characteristics at $V_{CC\pm}$ = ±15 V, T_A = 25°C (unless otherwise noted)

PARAMETER		TEST CONDITIONS		TLE2062Y MIN	TLE2062Y TYP	TLE2062Y MAX	UNIT
V_{IO}	Input offset voltage	V_{IC} = 0,	R_S = 50 Ω		0.9	4	mV
α_{VIO}	Input offset voltage long-term drift (see Note 4)				0.04		μV/mo
I_{IO}	Input offset current				2		pA
I_{IB}	Input bias current				4		pA
V_{ICR}	Common-mode input voltage range			–11 to 13	–12 to 16		V
V_{OM+}	Maximum positive peak output voltage swing	R_L = 10 kΩ		13.2	13.7		V
		R_L = 600 Ω		12.5	13.2		
V_{OM-}	Maximum negative peak output voltage swing	R_L = 10 kΩ		–13.2	–13.7		V
		R_L = 600 Ω		–12.5	–13		
A_{VD}	Large-signal differential voltage amplification	V_O = ±10 V,	R_L = 10 kΩ	30	230		V/mV
		V_O = 0 to 8 V,	R_L = 600 Ω	25	100		
		V_O = 0 to –8 V,	R_L = 600 Ω	3	25		
r_i	Input resistance				10^{12}		Ω
c_i	Input capacitance				4		pF
z_o	Open-loop output impedance	I_O = 0			560		Ω
CMRR	Common-mode rejection ratio	V_{IC} = V_{ICR}min,	R_S = 50 Ω	72	90		dB
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC}/\Delta V_{IO}$)	$V_{CC\pm}$ = ±5 V to ±15 V, R_S = 50 Ω		75	93		dB
I_{CC}	Supply current	V_O = 0,	No load		625	690	μA

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150 °C extrapolated to T_A = 25 °C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2062Y operating characteristics at $V_{CC\pm}$ = ±15 V, T_A = 25°C

PARAMETER		TEST CONDITIONS		TLE2062Y MIN	TLE2062Y TYP	TLE2062Y MAX	UNIT
SR	Slew rate at unity gain (see Figure 1)	R_L = 10 kΩ,	C_L = 100 pF	2.6	3.4	4	V/μs
V_n	Equivalent input noise voltage (see Figure 2)	f = 10 Hz,	R_S = 20 Ω		70		nV/√Hz
		f = 1 kHz,	R_S = 20 Ω		40		
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 Hz to 10 Hz			1.1		μV
I_n	Equivalent input noise current	f = 1 Hz			1.1		fA/√Hz
THD	Total harmonic distortion	$V_{O(PP)}$ = 2 V, A_{VD} = 2,	R_L = 10 kΩ, f = 10 kHz		0.025%		
B_1	Unity-gain bandwidth (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF		2		MHz
		R_L = 600 Ω,	C_L = 100 pF		1.5		
	Settling time	0.1%			5		μs
		0.01%			10		
B_{OM}	Maximum output-swing bandwidth	A_{VD} = 1,	R_L = 10 kΩ		40		kHz
ϕ_m	Phase margin at unity gain (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF		60°		
		R_L = 600 Ω,	C_L = 100 pF		70°		

TLE2064C electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±5 V (unless otherwise noted)

PARAMETER			TEST CONDITIONS	T_A†	TLE2064C TLE2064AC TLE2064BC			UNIT
					MIN	TYP	MAX	
V_{IO}	Input offset voltage	TLE2064C	V_{IC} = 0, R_S = 50 Ω	25°C		1.2	7	mV
				Full range			7.9	
		TLE2064AC		25°C		1.2	6	
				Full range			6.9	
		TLE2064BC		25°C		0.8	3.5	
				Full range			4.4	
α_{VIO}	Temperature coefficient of input offset voltage			25°C		6		μV/°C
	Input offset voltage long-term drift (see Note 4)			Full range		0.04		μV/mo
I_{IO}	Input offset current			25°C		1		pA
				Full range			0.8	nA
I_{IB}	Input bias current			25°C		3		pA
				Full range			2	nA
V_{ICR}	Common-mode input voltage range			25°C	−1.6 to 4	−2 to 6		V
				Full range	−1.6 to 4			V
V_{OM+}	Maximum positive peak output voltage swing		R_L = 10 kΩ	25°C	3.5	3.7		V
				Full range	3.3			
			R_L = 100 Ω	25°C	2.5	3.1		
				Full range	2			
V_{OM-}	Maximum negative peak output voltage swing		R_L = 10 kΩ	25°C	−3.7	−3.9		V
				Full range	−3.3			
			R_L = 100 Ω	25°C	−2.5	−2.7		
				Full range	−2			
A_{VD}	Large-signal differential voltage amplification		V_O = ±2.8 V, R_L = 10 kΩ	25°C	15	80		V/mV
				Full range	2			
			V_O = 0 to 2 V, R_L = 100 Ω	25°C	0.75	45		
				Full range	0.5			
			V_O = 0 to −2 V, R_L = 100 Ω	25°C	0.5	3		
				Full range	0.15			
r_i	Input resistance			25°C		10^{12}		Ω
c_i	Input capacitance			25°C		4		pF
z_o	Open-loop output impedance		I_O = 0	25°C		560		Ω
CMRR	Common-mode rejection ratio		V_{IC} = V_{ICR}min, R_S = 50 Ω	25°C	65	82		dB
				Full range	65			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)		$V_{CC\pm}$ = ±5 V to ±15 V, R_S = 50 Ω	25°C	75	93		dB
				Full range	75			

† Full range is 0°C to 70°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2064C electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±5 V (unless otherwise noted) (continued)

PARAMETER		TEST CONDITIONS		T_A†	TLE2064C TLE2064AC TLE2064BC			UNIT
					MIN	TYP	MAX	
I_{CC}	Supply current (four amplifiers)	V_O = 0,	No load	25°C		1.12	1.3	mA
				Full range			1.3	
ΔI_{CC}	Supply-current change over operating temperature range (four amplifiers)			Full range		52		μA
V_{O1}/V_{O2}	Crosstalk attenuation	A_{VD} = 1000,	f = 1 kHz	25°C		120		dB

† Full range is 0°C to 70°C.

TLE2064C operating characteristics at specified free-air temperature, $V_{CC\pm}$ = ±5 V

PARAMETER		TEST CONDITIONS		T_A†	TLE2064C TLE2064AC TLE2064BC			UNIT
					MIN	TYP	MAX	
SR	Slew rate at unity gain (see Figure 1)	R_L = 10 kΩ,	C_L = 100 pF	25°C	2.2	3.4		V/μs
				Full range	2.1			
V_n	Equivalent input noise voltage (see Figure 2)	f = 10 Hz,	R_S = 20 Ω	25°C		59	100	nV/√Hz
		f = 1 kHz,	R_S = 20 Ω			43	60	
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 Hz to 10 Hz		25°C		1.1		μV
I_n	Equivalent input noise current	f = 1 kHz		25°C		1		fA/√Hz
THD	Total harmonic distortion	A_{VD} = 2, $V_{O(PP)}$ = 2 V,	f = 10 kHz, R_L = 10 kΩ	25°C		0.025%		
B_1	Unity-gain bandwidth (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF	25°C		1.8		MHz
		R_L = 100 Ω,	C_L = 100 pF			1.3		
t_s	Settling time	ε = 0.1%		25°C		5		μs
		ε = 0.01%				10		
B_{OM}	Maximum output-swing bandwidth	A_{VD} = 1,	R_L = 10 kΩ	25°C		140		kHz
ϕ_m	Phase margin at unity gain (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF	25°C		58°		
		R_L = 100 Ω,	C_L = 100 pF			75°		

† Full range is 0°C to 70°C.

TLE2064C electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±15 V (unless otherwise noted)

PARAMETER			TEST CONDITIONS	T_A†	TLE2064C TLE2064AC TLE2064BC			UNIT
					MIN	TYP	MAX	
V_{IO}	Input offset voltage	TLE2064C	V_{IC} = 0, R_S = 50 Ω	25°C		0.9	6	mV
				Full range			6.9	
		TLE2064AC		25°C		0.9	4	
				Full range			4.9	
		TLE2064BC		25°C		0.7	2	
				Full range			4	
α_{VIO}	Temperature coefficient of input offset voltage			25°C		6		μV/°C
	Input offset voltage long-term drift (see Note 4)			Full range		0.04		μV/mo
I_{IO}	Input offset current			25°C		2		pA
				Full range			1	nA
I_{IB}	Input bias current			25°C		4		pA
				Full range			3	nA
V_{ICR}	Common-mode input voltage range			25°C	−11 to 13	−12 to 16		V
				Full range	−11 to 13			V
V_{OM+}	Maximum positive peak output voltage swing		R_L = 10 kΩ	25°C	13.2	13.7		V
				Full range	13			
			R_L = 600 Ω	25°C	12.5	13.2		
				Full range	12			
V_{OM-}	Maximum negative peak output voltage swing		R_L = 10 kΩ	25°C	−13.2	−13.7		V
				Full range	−13			
			R_L = 600 Ω	25°C	−12.5	−13		
				Full range	−12			
A_{VD}	Large-signal differential voltage amplification		V_O = ±10 V, R_L = 10 kΩ	25°C	30	230		V/mV
				Full range	20			
			V_O = 0 to 8 V, R_L = 600 Ω	25°C	25	100		
				Full range	10			
			V_O = 0 to −8 V, R_L = 600 Ω	25°C	3	25		
				Full range	1			
r_i	Input resistance			25°C		10^{12}		Ω
c_i	Input capacitance			25°C		4		pF
z_o	Open-loop output impedance		I_O = 0	25°C		560		Ω
CMRR	Common-mode rejection ratio		V_{IC} = V_{ICR}min, R_S = 50 Ω	25°C	72	90		dB
				Full range	70			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)		$V_{CC\pm}$ = ±5 V to ±15 V, R_S = 50 Ω	25°C	75	93		dB
				Full range	75			

† Full range is 0°C to 70°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2064C electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±15 V (unless otherwise noted) (continued)

PARAMETER		TEST CONDITIONS		T_A†	TLE2064C TLE2064AC TLE2064BC			UNIT
					MIN	TYP	MAX	
I_{CC}	Supply current (four amplifiers)	V_O = 0,	No load	25°C		1.25	1.4	mA
				Full range			1.5	
ΔI_{CC}	Supply-current change over operating temperature range (four amplifiers)			Full range		72		μA
V_{O1}/V_{O2}	Crosstalk attenuation	A_{VD} = 1000,	f = 1 kHz	25°C		120		dB

† Full range is 0°C to 70°C.

TLE2064C operating characteristics at specified free-air temperature, $V_{CC\pm}$ = ±15 V

PARAMETER		TEST CONDITIONS		T_A†	TLE2064C TLE2064AC TLE2064BC			UNIT
					MIN	TYP	MAX	
SR	Slew rate at unity gain (see Figure 1)	R_L = 10 kΩ,	C_L = 100 pF	25°C	2.6	3.4		V/μs
				Full range	2.5			
V_n	Equivalent input noise voltage (see Figure 2)	f = 10 Hz,	R_S = 20 Ω	25°C		70	100	nV/√Hz
		f = 1 kHz,	R_S = 20 Ω			40	60	
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 Hz to 10 Hz		25°C		1.1		μV
I_n	Equivalent input noise current	f = 1 kHz		25°C		1		fA/√Hz
THD	Total harmonic distortion	A_{VD} = 2, $V_{O(PP)}$ = 2 V,	f = 10 kHz, R_L = 10 kΩ	25°C		0.025%		
B_1	Unity-gain bandwidth (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF	25°C		2		MHz
		R_L = 600 Ω,	C_L = 100 pF			1.5		
t_s	Settling time	ε = 0.1%		25°C		5		μs
		ε = 0.01%				10		
B_{OM}	Maximum output-swing bandwidth	A_{VD} = 1,	R_L = 10 kΩ	25°C		40		kHz
ϕ_m	Phase margin at unity gain (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF	25°C		50°		
		R_L = 600 Ω,	C_L = 100 pF			70°		

† Full range is 0°C to 70°C.

TLE2064I electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±5 V (unless otherwise noted)

PARAMETER			TEST CONDITIONS	T_A†	TLE2064I TLE2064AI TLE2064BI			UNIT
					MIN	TYP	MAX	
V_{IO}	Input offset voltage	TLE2064I	V_{IC} = 0, R_S = 50 Ω	25°C		1.2	7	mV
				Full range			8.3	
		TLE2064AI		25°C		1.2	6	
				Full range			7.3	
		TLE2064BI		25°C		0.8	3.5	
				Full range			4.8	
α_{VIO}	Temperature coefficient of input offset voltage			25°C		6		μV/°C
	Input offset voltage long-term drift (see Note 4)			Full range		0.04		μV/mo
I_{IO}	Input offset current			25°C		1		pA
				Full range			2	nA
I_{IB}	Input bias current			25°C		3		pA
				Full range			4	nA
V_{ICR}	Common-mode input voltage range			25°C	−1.6 to 4	−2 to 6		V
				Full range	−1.6 to 4			V
V_{OM+}	Maximum positive peak output voltage swing		R_L = 10 kΩ	25°C	3.5	3.7		V
				Full range	3.1			
			R_L = 100 Ω	25°C	2.5	3.1		
				Full range	2			
V_{OM-}	Maximum negative peak output voltage swing		R_L = 10 kΩ	25°C	−3.7	−3.9		V
				Full range	−3.1			
			R_L = 100 Ω	25°C	−2.5	−2.7		
				Full range	−2			
A_{VD}	Large-signal differential voltage amplification		V_O = ±2.8 V, R_L = 10 kΩ	25°C	15	80		V/mV
				Full range	2			
			V_O = 0 to 2 V, R_L = 100 Ω	25°C	0.75	45		
				Full range	0.5			
			V_O = 0 to −2 V, R_L = 100 Ω	25°C	0.5	3		
				Full range	0.15			
r_i	Input resistance			25°C		10^{12}		Ω
c_i	Input capacitance			25°C		4		pF
z_o	Open-loop output impedance		I_O = 0	25°C		560		Ω
CMRR	Common-mode rejection ratio		V_{IC} = V_{ICR}min, R_S = 50 Ω	25°C	65	82		dB
				Full range	65			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)		$V_{CC\pm}$ = ±5 V to ±15 V, R_S = 50 Ω	25°C	75	93		dB
				Full range	65			

† Full range is −40°C to 85°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2064I electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±5 V (unless otherwise noted) (continued)

PARAMETER		TEST CONDITIONS	T_A†	TLE2064I TLE2064AI TLE2064BI			UNIT
				MIN	TYP	MAX	
I_{CC}	Supply current (four amplifiers)	V_O = 0, No load	25°C		1.12	1.3	mA
			Full range			1.3	
ΔI_{CC}	Supply-current change over operating temperature range (four amplifiers)		Full range		108		μA
V_{O1}/V_{O2}	Crosstalk attenuation	A_{VD} = 1000, f = 1 kHz	25°C		120		dB

† Full range is –40°C to 85°C.

TLE2064I operating characteristics at specified free-air temperature, $V_{CC\pm}$ = ±5 V (unless otherwise noted)

PARAMETER		TEST CONDITIONS	T_A†	TLE2064I TLE2064AI TLE2064BI			UNIT
				MIN	TYP	MAX	
SR	Slew rate at unity gain (see Figure 1)	R_L = 10 kΩ, C_L = 100 pF	25°C	2.2	3.4		V/μs
			Full range	1.7			
V_n	Equivalent input noise voltage (see Figure 2)	f = 10 Hz, R_S = 20 Ω	25°C		59	100	nV/√Hz
		f = 1 kHz, f = 1 kHz,			43	60	
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 Hz to 10 Hz	25°C		1.1		μV
I_n	Equivalent input noise current	f = 1 kHz	25°C		1		fA/√Hz
THD	Total harmonic distortion	A_{VD} = 2, f = 10 kHz, $V_{O(PP)}$ = 2 V, R_L = 10 kΩ	25°C		0.025%		
B_1	Unity-gain bandwidth (see Figure 3)	R_L = 10 kΩ, C_L = 100 pF	25°C		1.8		MHz
		R_L = 100 Ω, C_L = 100 pF			1.3		
t_s	Settling time	ε = 0.1%	25°C		5		μs
		ε = 0.01%			10		
B_{OM}	Maximum output-swing bandwidth	A_{VD} = 1, R_L = 10 kΩ	25°C		140		kHz
ϕ_m	Phase margin at unity gain (see Figure 3)	R_L = 10 kΩ, C_L = 100 pF	25°C		58°		
		R_L = 100 Ω, C_L = 100 pF			75°		

† Full range is – 40°C to 85°C.

TLE2064I electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±15 V (unless otherwise noted)

PARAMETER			TEST CONDITIONS	T_A†	TLE2064I TLE2064AI TLE2064BI			UNIT
					MIN	TYP	MAX	
V_{IO}	Input offset voltage	TLE2064I	V_{IC} = 0, R_S = 50 Ω	25°C		0.9	6	mV
				Full range			7.3	
		TLE2064AI		25°C		0.9	4	
				Full range			5.3	
		TLE2064BI		25°C		0.7	2	
				Full range			3.3	
α_{VIO}	Temperature coefficient of input offset voltage			25°C		6		μV/°C
	Input offset voltage long-term drift (see Note 4)			Full range		0.04		μV/mo
I_{IO}	Input offset current			25°C		2		pA
				Full range			3	nA
I_{IB}	Input bias current			25°C		4		pA
				Full range			5	nA
V_{ICR}	Common-mode input voltage range			25°C	–11 to 13	–12 to 16		V
				Full range	–11 to 13			V
V_{OM+}	Maximum positive peak output voltage swing		R_L = 10 kΩ	25°C	13.2	13.7		V
				Full range	13			
			R_L = 600 Ω	25°C	12.5	13.2		
				Full range	12			
V_{OM-}	Maximum negative peak output voltage swing		R_L = 10 kΩ	25°C	–13.2	–13.7		V
				Full range	–13			
			R_L = 600 Ω	25°C	–12.5	–13		
				Full range	–12			
A_{VD}	Large-signal differential voltage amplification		V_O = ±10 V, R_L = 10 kΩ	25°C	30	230		V/mV
				Full range	20			
			V_O = 0 to 8 V, R_L = 600 Ω	25°C	25	100		
				Full range	10			
			V_O = 0 to –8 V, R_L = 600 Ω	25°C	3	25		
				Full range	1			
r_i	Input resistance			25°C		10^{12}		Ω
c_i	Input capacitance			25°C		4		pF
z_o	Open-loop output impedance		I_O = 0	25°C		560		Ω
CMRR	Common-mode rejection ratio		V_{IC} = V_{ICR}min, R_S = 50 Ω	25°C	72	90		dB
				Full range	65			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)		$V_{CC\pm}$ = ±5 V to ±15 V, R_S = 50 Ω	25°C	75	93		dB
				Full range	65			

† Full range is – 40°C to 85°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2064I electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±15 V (unless otherwise noted) (continued)

PARAMETER		TEST CONDITIONS	T_A†	TLE2064I TLE2064AI TLE2064BI			UNIT
				MIN	TYP	MAX	
I_{CC}	Supply current (four amplifiers)	V_O = 0, No load	25°C		1.25	1.4	mA
			Full range			1.5	
ΔI_{CC}	Supply-current change over operating temperature range (four amplifiers)		Full range		148		μA
V_{O1}/V_{O2}	Crosstalk attenuation	A_{VD} = 1000, f = 1 kHz	25°C		120		dB

† Full range is – 40°C to 85°C.

TLE2064I operating characteristics at specified free-air temperature, $V_{CC\pm}$ = ± 15 V

PARAMETER		TEST CONDITIONS	T_A†	TLE2064I TLE2064AI TLE2064BI			UNIT
				MIN	TYP	MAX	
SR	Slew rate at unity gain (see Figure 1)	R_L = 10 kΩ, C_L = 100 pF	25°C	2.6	3.4		V/μs
			Full range	2.1			
V_n	Equivalent input noise voltage (see Figure 2)	f = 10 Hz, R_S = 20 Ω,	25°C		70	100	nV/√Hz
		f = 1 kHz, R_S = 20 Ω			40	60	
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 Hz to 10 Hz	25°C		1.1		μV
I_n	Equivalent input noise current	f = 1 kHz	25°C		1.1		fA/√Hz
THD	Total harmonic distortion	A_{VD} = 2, f = 10 kHz, R_L = 10 kΩ $V_{O(PP)}$ = 2 V,	25°C		0.025%		
B_1	Unity-gain bandwidth (see Figure 3)	R_L = 10 kΩ, C_L = 100 pF	25°C		2		MHz
		R_L = 600 Ω, C_L = 100 pF			1.5		
t_s	Settling time	ε = 0.1%	25°C		5		μs
		ε = 0.01%			10		
B_{OM}	Maximum output-swing bandwidth	A_{VD} = 1, R_L = 10 kΩ	25°C		40		kHz
ϕ_m	Phase margin at unity gain (see Figure 3)	R_L = 10 kΩ, C_L = 100 pF	25°C		60°		
		R_L = 600 Ω, C_L = 100 pF			70°		

† Full range is – 40°C to 85°C.

TLE2064M electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±5 V (unless otherwise noted)

PARAMETER			TEST CONDITIONS	T_A†	TLE2064M TLE2064AM TLE2064BM			UNIT
					MIN	TYP	MAX	
V_{IO}	Input offset voltage	TLE2064M	V_{IC} = 0, R_S = 50 Ω	25°C		1.2	7	mV
				Full range			9	
		TLE2064AM		25°C		1.2	6	
				Full range			8	
		TLE2064BM		25°C		0.8	3.5	
				Full range			5.5	
α_{VIO}	Temperature coefficient of input offset voltage			25°C		6		μV/°C
	Input offset voltage long-term drift (see Note 4)			Full range		0.04		μV/mo
I_{IO}	Input offset current			25°C		1		pA
				Full range			15	nA
I_{IB}	Input bias current			25°C		3		pA
				Full range			30	nA
V_{ICR}	Common-mode input voltage range			25°C	–1.6 to 4	–2 to 6		V
				Full range	–1.6 to 4			V
V_{OM+}	Maximum positive peak output voltage swing		R_L = 10 kΩ	25°C	3.5	3.7		V
				Full range	3			
		FK and J packages	R_L = 600 Ω	25°C	2.5	3.6		
				Full range	2			
		D and N packages	R_L = 100 Ω	25°C	2.5	3.1		
				Full range	2			
V_{OM-}	Maximum negative peak output voltage swing		R_L = 10 kΩ	25°C	–3.5	–3.9		V
				Full range	–3			
		FK and J packages	R_L = 600 Ω	25°C	–2.5	–3.5		
				Full range	–2			
		D and N packages	R_L = 100 Ω	25°C	–2.5	–2.7		
				Full range	–2			
A_{VD}	Large-signal differential voltage amplification		V_O = ±2.8 V, R_L = 10 kΩ	25°C	15	80		V/mV
				Full range	2			
		FK and J packages	V_O = 0 to 2.5 V, R_L = 600 Ω	25°C	1	65		
				Full range	0.5			
			V_O = 0 to –2.5 V, R_L = 600 Ω	25°C	1	16		
				Full range	0.5			

† Full range is – 55°C to 125°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2064M electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±5 V (unless otherwise noted) continued)

PARAMETER			TEST CONDITIONS	T_A†	TLE2064M TLE2064AM TLE2064BM			UNIT
					MIN	TYP	MAX	
A_{VD}	Large-signal differential voltage amplification	D and N packages	V_O = 0 to 2 V, R_L = 100 Ω	25°C	0.75	45		V/mV
				Full range	0.25			
			V_O = 0 to –2 V, R_L = 100 Ω	25°C	0.4	3		
				Full range	0.15			
r_i	Input resistance			25°C		10^{12}		Ω
c_i	Input capacitance			25°C		4		pF
z_o	Open-loop output impedance		I_O = 0	25°C		560		Ω
CMRR	Common-mode rejection ratio		V_{IC} = V_{ICR}min, R_S = 50 Ω	25°C	65	82		dB
				Full range	60			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)		$V_{CC\pm}$ = ±5 V to ±15 V, R_S = 50 Ω	25°C	75	93		dB
				Full range	65			
I_{CC}	Supply current (four amplifiers)		V_O = 0, No load	25°C		1.12	1.3	mA
				Full range			1.3	
ΔI_{CC}	Supply-current change over operating temperature range (four amplifiers)		V_O = 0, No load	Full range		144		μA
V_{O1}/V_{O2}	Crosstalk attenuation		A_{VD} = 1000, f = 1 kHz	25°C		120		dB

† Full range is –55°C to 125°C.

TLE2064M operating characteristics, $V_{CC\pm}$ = ±5 V, T_A = 25°C

PARAMETER		TEST CONDITIONS		TLE2064M TLE2064AM TLE2064BM			UNIT
				MIN	TYP	MAX	
SR	Slew rate at unity gain (see Figure 1)	R_L = 10 kΩ,	C_L = 100 pF		3.4		V/μs
V_n	Equivalent input noise voltage (see Figure 2)	f = 10 Hz,	R_S = 20 Ω		59		nV/√Hz
		f = 1 kHz,	R_S = 20 Ω		43		
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 Hz to 10 Hz			1.1		μV
I_n	Equivalent input noise current	f = 1 kHz			1		fA/√Hz
THD	Total harmonic distortion	A_{VD} = 2, $V_{O(PP)}$ = 2 V,	f = 10 kHz, R_L = 10 kΩ		0.025%		
B_1	Unity-gain bandwidth (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF		1.8		MHz
		R_L = 600 Ω,	C_L = 100 pF		1.3		
t_s	Settling time	ε = 0.1%			5		μs
		ε = 0.01%			10		
B_{OM}	Maximum output-swing bandwidth	A_{VD} = 1,	R_L = 10 kΩ		140		kHz
ϕ_m	Phase margin at unity gain (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF		58°		
		R_L = 600 Ω,	C_L = 100 pF		75°		

TLE2064M electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±15 V (unless otherwise noted)

PARAMETER			TEST CONDITIONS	T_A†	TLE2064M TLE2064AM TLE2064BM			UNIT
					MIN	TYP	MAX	
V_{IO}	Input offset voltage	TLE2064M	V_{IC} = 0, R_S = 50 Ω	25°C		0.9	6	mV
				Full range			8	
		TLE2064AM		25°C		0.9	4	
				Full range			6	
		TLE2064BM		25°C		0.7	2	
				Full range			4	
α_{VIO}	Temperature coefficient of input offset voltage			25°C		6		μV/°C
	Input offset voltage long-term drift (see Note 4)			Full range		0.04		μV/mo
I_{IO}	Input offset current			25°C		2		pA
				Full range			20	nA
I_{IB}	Input bias current			25°C		4		pA
				Full range			40	nA
V_{ICR}	Common-mode input voltage range			25°C	–11 to 13	–12 to 16		V
				Full range	–11 to 13			V
V_{OM+}	Maximum positive peak output voltage swing		R_L = 10 kΩ	25°C	13	13.7		V
				Full range	12.5			
			R_L = 600 Ω	25°C	12.5	13.2		
				Full range	12			
V_{OM-}	Maximum negative peak output voltage swing		R_L = 10 kΩ	25°C	–13	–13.7		V
				Full range	–12.5			
			R_L = 600 Ω	25°C	–13	–13		
				Full range	–12.5			
A_{VD}	Large-signal differential voltage amplification		V_O = ±10 V, R_L = 10 kΩ	25°C	30	230		V/mV
				Full range	20			
			V_O = 0 to 8 V, R_L = 600 Ω	25°C	25	100		
				Full range	7			
			V_O = 0 to –8 V, R_L = 600 Ω	25°C	3	25		
				Full range	1			
r_i	Input resistance			25°C		10^{12}		Ω
c_i	Input capacitance			25°C		4		pF
z_o	Open-loop output impedance		I_O = 0	25°C		560		Ω
CMRR	Common-mode rejection ratio		V_{IC} = V_{ICR}min, R_S = 50 Ω	25°C	72	90		dB
				Full range	65			
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)		$V_{CC\pm}$ = ±5 V to ±15 V, R_S = 50 Ω	25°C	75	93		dB
				Full range	65			

† Full range is – 55°C to 125°C.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2064M electrical characteristics at specified free-air temperature, $V_{CC\pm}$ = ±15 V (unless otherwise noted) (continued)

PARAMETER		TEST CONDITIONS	T_A†	TLE2064M TLE2064AM TLE2064BM			UNIT
				MIN	TYP	MAX	
I_{CC}	Supply current (four amplifiers)	V_O = 0, No load	25°C		1.25	1.4	mA
			Full range			1.5	
ΔI_{CC}	Supply-current change over operating temperature range (four amplifiers)		Full range		194		μA
V_{O1}/V_{O2}	Crosstalk attenuation	A_{VD} = 1000, f = 1 kHz	25°C		120		dB

† Full range is – 55°C to 125°C.

TLE2064M operating characteristics at specified free-air temperature, $V_{CC\pm}$ = ±15 V

PARAMETER		TEST CONDITIONS	T_A†	TLE2064M TLE2064AM TLE2064BM			UNIT
				MIN	TYP	MAX	
SR	Slew rate at unity gain (see Figure 1)	R_L = 10 kΩ, C_L = 100 pF	25°C	2.6	3.4		V/μs
			Full range	1.8			
V_n	Equivalent input noise voltage (see Figure 2)	f = 10 Hz, R_S = 20 Ω	25°C		70		nV/√Hz
		f = 1 kHz, R_S = 20 Ω			40		
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 Hz to 10 Hz	25°C		1.1		μV
I_n	Equivalent input noise current	f = 1 kHz	25°C		1.1		fA/√Hz
THD	Total harmonic distortion	A_{VD} = 2, f = 10 kHz, $V_{O(PP)}$ = 2 V, R_L = 10 kΩ	25°C		0.025%		
B_1	Unity-gain bandwidth (see Figure 3)	R_L = 10 kΩ, C_L = 100 pF	25°C		2		MHz
		R_L = 600 Ω, C_L = 100 pF			1.5		
t_s	Settling time	ε = 0.1%	25°C		5		μs
		ε = 0.01%			10		
B_{OM}	Maximum output-swing bandwidth	A_{VD} = 1, R_L = 10 kΩ	25°C		40		kHz
ϕ_m	Phase margin at unity gain (see Figure 3)	R_L = 10 kΩ, C_L = 100 pF	25°C		60°		
		R_L = 600 Ω, C_L = 100 pF			70°		

† Full range is – 55°C to 125°C.

TLE2064Y electrical characteristics at $V_{CC\pm}$ = ±15 V, T_A = 25°C (unless otherwise noted)

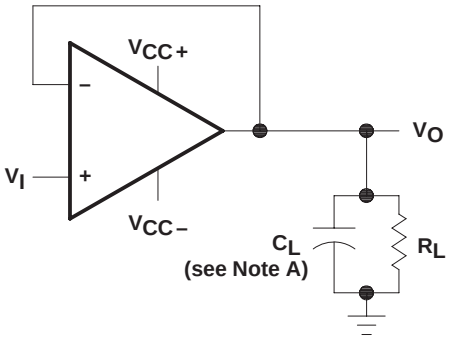
PARAMETER		TEST CONDITIONS		TLE2064Y			UNIT
				MIN	TYP	MAX	
V_{IO}	Input offset voltage	V_{IC} = 0,	R_S = 50 Ω		0.9	6	mV
α_{VIO}	Input offset voltage long-term drift (see Note 4)				0.04		μV/mo
I_{IO}	Input offset current				2		pA
I_{IB}	Input bias current				4		pA
V_{ICR}	Common-mode input voltage range			–11 to 13	–12 to 16		V
V_{OM+}	Maximum positive peak output voltage swing	R_L = 10 kΩ		13.2	13.7		V
		R_L = 600 Ω		12.5	13.2		
V_{OM-}	Maximum negative peak output voltage swing	R_L = 10 kΩ		–13.2	–13.7		V
		R_L = 600 Ω		12.5	13		V
A_{VD}	Large-signal differential voltage amplification	V_O = ±10 V,	R_L = 10 kΩ	30	230		V/mV
		V_O = 0 to 8 V,	R_L = 600 Ω	25	100		
		V_O = 0 to –8 V,	R_L = 600 Ω	3	25		
r_i	Input resistance				10^{12}		Ω
c_i	Input capacitance				4		pF
z_o	Open-loop output impedance	I_O = 0			560		Ω
CMRR	Common-mode rejection ratio	R_S = 50 Ω, V_{IC} = V_{ICR}min,		72	90		dB
k_{SVR}	Supply-voltage rejection ratio ($\Delta V_{CC\pm}/\Delta V_{IO}$)	$V_{CC\pm}$ = ±5 V to ±15 V, R_S = 50 Ω		75	93		dB
I_{CC}	Supply current	V_O = 0,	No load		1.25	1.4	mA
V_{O1}/V_{O2}	Crosstalk attenuation	A_{VD} = 1000,	f = 1 kHz		120		dB

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at T_A = 150°C extrapolated to T_A = 25°C using the Arrhenius equation and assuming an activation energy of 0.96 eV.

TLE2064Y operating characteristics at $V_{CC\pm}$ = ±15 V, T_A = 25°C

PARAMETER		TEST CONDITIONS		TLE2064Y			UNIT
				MIN	TYP	MAX	
SR	Slew rate at unity gain (see Figure 1)	R_L = 10 kΩ,	C_L = 100 pF	2.6	3.4		V/μs
V_n	Equivalent input noise voltage (see Figure 2)	f = 10 Hz,	R_S = 20 Ω		70		nV/√Hz
		f = 1 kHz,	R_S = 20 Ω		40		
$V_{N(PP)}$	Peak-to-peak equivalent input noise voltage	f = 0.1 Hz to 10 Hz			1.1		μV
I_n	Equivalent input noise current	f = 1 kHz			1.1		fA/√Hz
THD	Total harmonic distortion	A_{VD} = 2, $V_{O(PP)}$ = 2 V,	f = 10 kHz, R_L = 10 kΩ		0.025%		
B_1	Unity-gain bandwidth (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF		2		MHz
		R_L = 600 Ω,	C_L = 100 pF		1.5		
t_s	Settling time	ε = 0.1%			5		μs
		ε = 0.01%			10		
B_{OM}	Maximum output-swing bandwidth	A_{VD} = 1,	R_L = 10 kΩ		40		kHz
ϕ_m	Phase margin at unity gain (see Figure 3)	R_L = 10 kΩ,	C_L = 100 pF		60°		
		R_L = 600 Ω,	C_L = 100 pF		70°		

PARAMETER MEASUREMENT INFORMATION



NOTE A: C_L includes fixture capacitance.

Figure 1. Slew-Rate Test Circuit

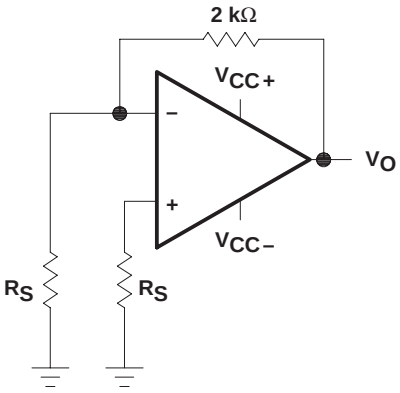
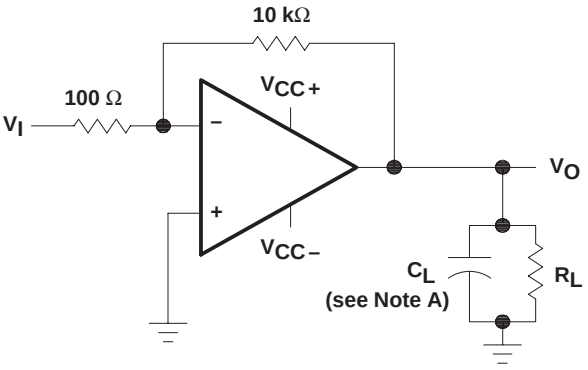


Figure 2. Noise-Voltage Test Circuit



NOTE A: C_L includes fixture capacitance.

Figure 3. Unity-Gain Bandwidth and Phase-Margin Test Circuit

typical values

Typical values presented in this data sheet represent the median (50% point) of device parametric performance.

input bias and offset current

At the picoampere bias current level typical of the TLE206x, TLE2064xA, and TLE206xB, accurate measurement of the bias current becomes difficult. Not only does this measurement require a picoammeter, but test socket leakages can easily exceed the actual device bias currents. To accurately measure these small currents, Texas Instruments uses a two-step process. The socket leakage is measured using picoammeters with bias voltages applied but with no device in the socket. The device is then inserted into the socket, and a second test that measures both the socket leakage and the device input bias current is performed. The two measurements are then subtracted algebraically to determine the bias current of the device.

TYPICAL CHARACTERISTICS

Table of Graphs

			FIGURE
V_{IO}	Input offset voltage	Distribution	4, 5, 6
I_{IB}	Input bias current	vs Common-mode input voltage vs Free-air temperature	7 8
I_{IO}	Input offset current	vs Free-air temperature	8
V_{ICR}	Common-mode input voltage	vs Free-air temperature	9
V_{OM}	Maximum peak output voltage	vs Output current vs Supply voltage	10, 11 12, 13, 14
$V_{O(PP)}$	Maximum peak-to-peak output voltage	vs Frequency vs Load resistance	15, 16 17
A_{VD}	Large-signal differential voltage amplification	vs Frequency vs Free-air temperature	18 19
I_{OS}	Short-circuit output current	vs Elasped time vs Free-air temperature	20 21
z_o	Output impedance	vs Frequency	22, 23
CMRR	Common-mode rejection ratio	vs Frequency	24
I_{CC}	Supply current	vs Supply voltage vs Free-air temperature	25, 26, 27 28, 29, 30
	Voltage-follower small-signal pulse response	vs Time	31, 32
	Voltage-follower large-signal pulse response	vs Time	33, 34
	Noise voltage (referred to input)	0.1 to 10 Hz	35
V_n	Equivalent input noise voltage	vs Frequency	36
THD	Total harmonic distortion	vs Frequency	37, 38
B_1	Unity-gain bandwidth	vs Supply voltage vs Free-air temperature	39 40
ϕ_m	Phase margin	vs Supply voltage vs Load capacitance vs Free-air temperature	41 42 43
	Phase shift	vs Frequency	18

TYPICAL CHARACTERISTICS

**TLE2061
DISTRIBUTION OF
INPUT OFFSET VOLTAGE**

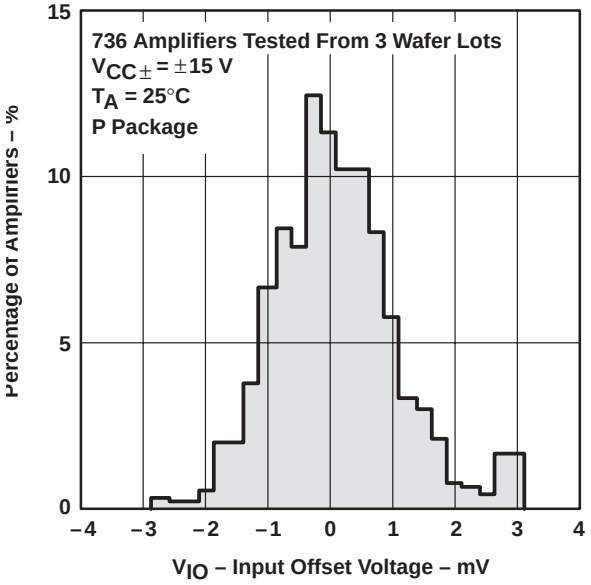


Figure 4

**TLE2062
DISTRIBUTION OF
INPUT OFFSET VOLTAGE**

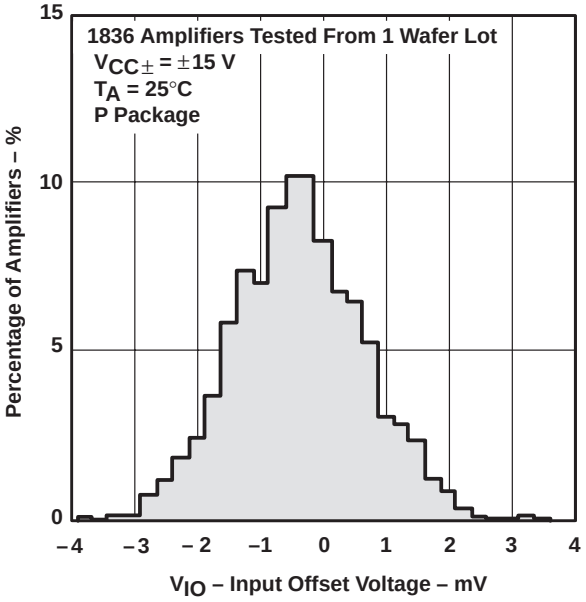


Figure 5

**TLE2064
DISTRIBUTION OF
INPUT OFFSET VOLTAGE**

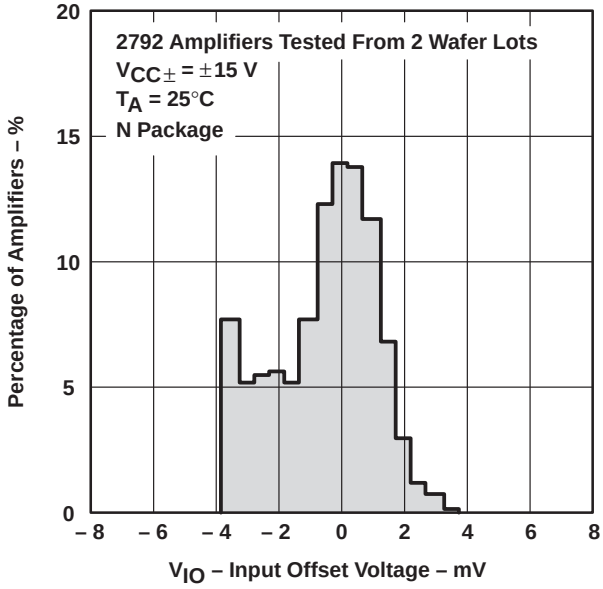


Figure 6

**INPUT BIAS CURRENT
vs
COMMON-MODE INPUT VOLTAGE**

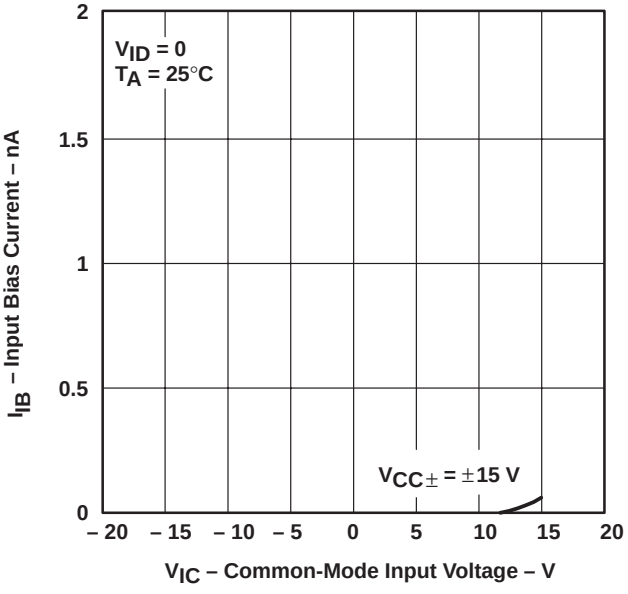


Figure 7

TYPICAL CHARACTERISTICS†

INPUT BIAS CURRENT AND INPUT OFFSET CURRENT vs FREE-AIR TEMPERATURE

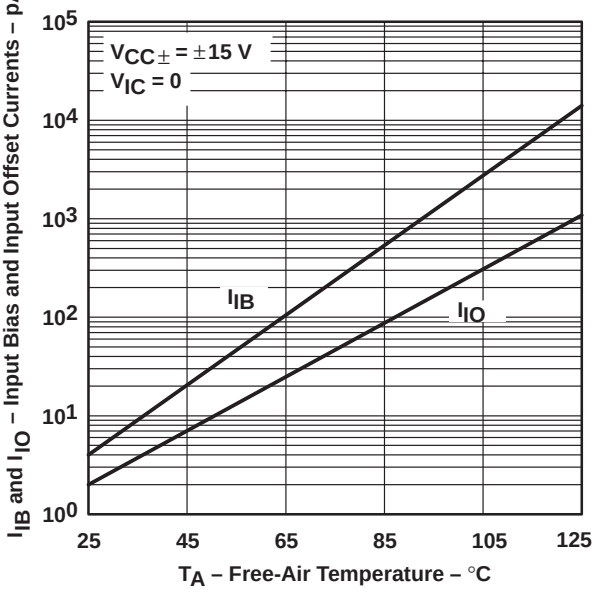


Figure 8

COMMON-MODE INPUT VOLTAGE vs FREE-AIR TEMPERATURE

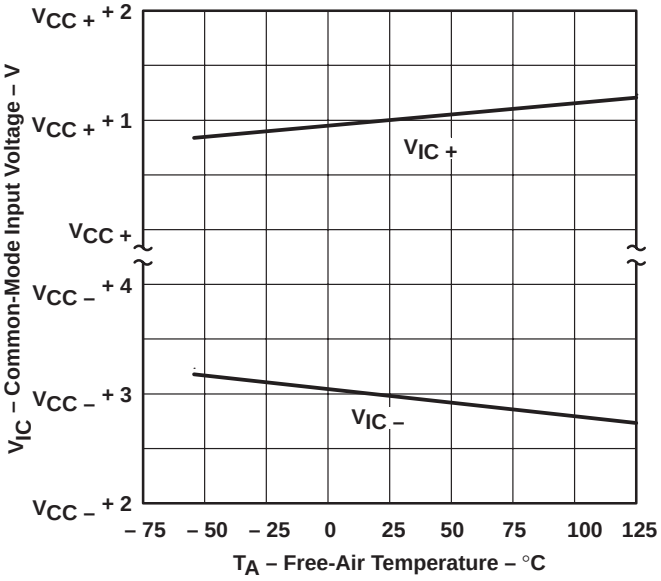


Figure 9

MAXIMUM POSITIVE PEAK OUTPUT VOLTAGE vs OUTPUT CURRENT

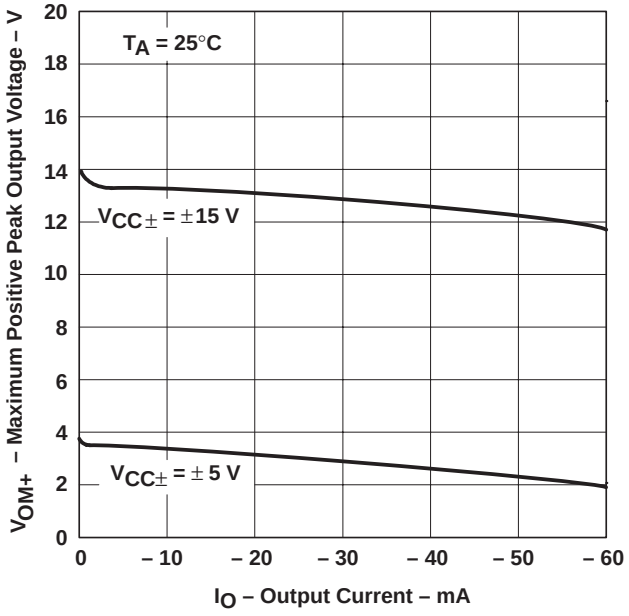


Figure 10

MAXIMUM NEGATIVE PEAK OUTPUT VOLTAGE vs OUTPUT CURRENT

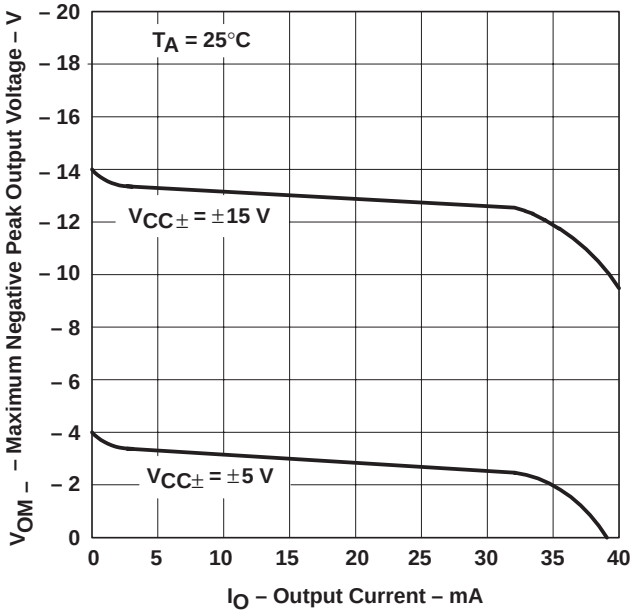


Figure 11

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS

MAXIMUM PEAK OUTPUT VOLTAGE vs SUPPLY VOLTAGE

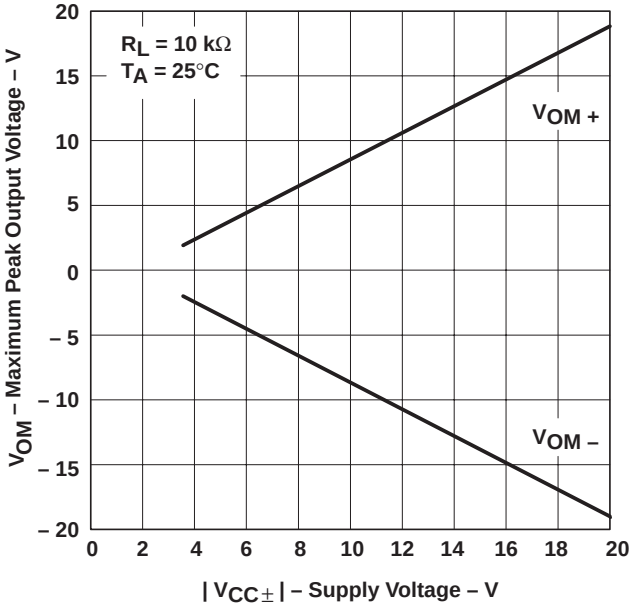


Figure 12

MAXIMUM PEAK OUTPUT VOLTAGE vs SUPPLY VOLTAGE

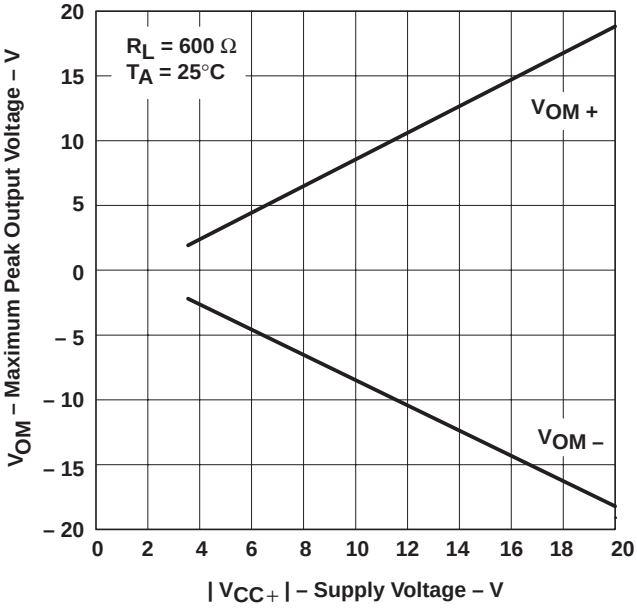


Figure 13

MAXIMUM PEAK OUTPUT VOLTAGE vs SUPPLY VOLTAGE

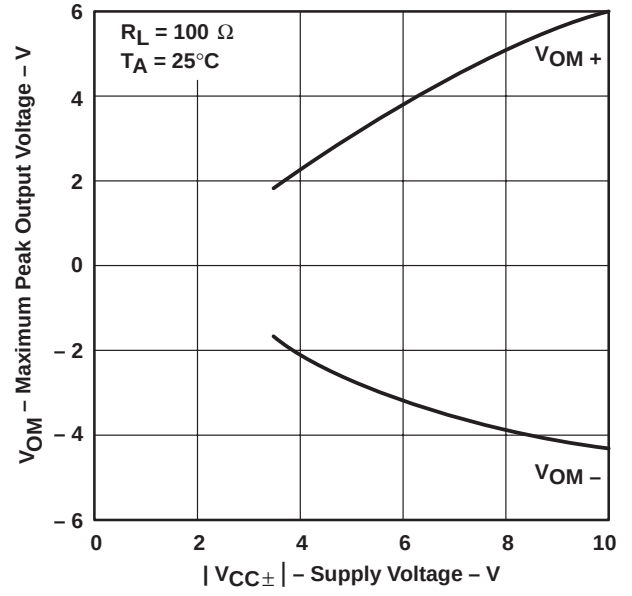


Figure 14

MAXIMUM PEAK-TO-PEAK OUTPUT VOLTAGE vs FREQUENCY

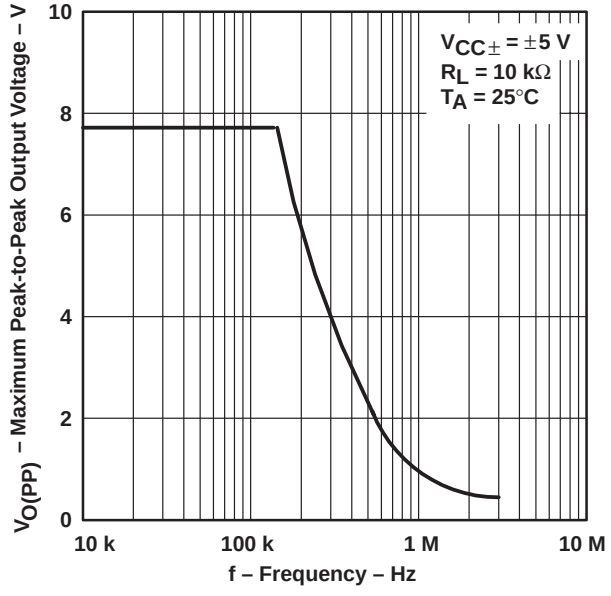


Figure 15

TYPICAL CHARACTERISTICS†

MAXIMUM PEAK-TO-PEAK
OUTPUT VOLTAGE
vs
FREQUENCY

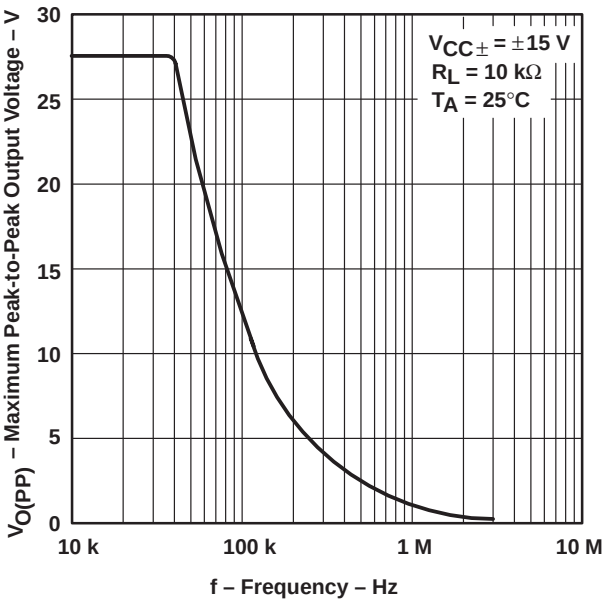


Figure 16

MAXIMUM PEAK-TO-PEAK
OUTPUT VOLTAGE
vs
LOAD RESISTANCE

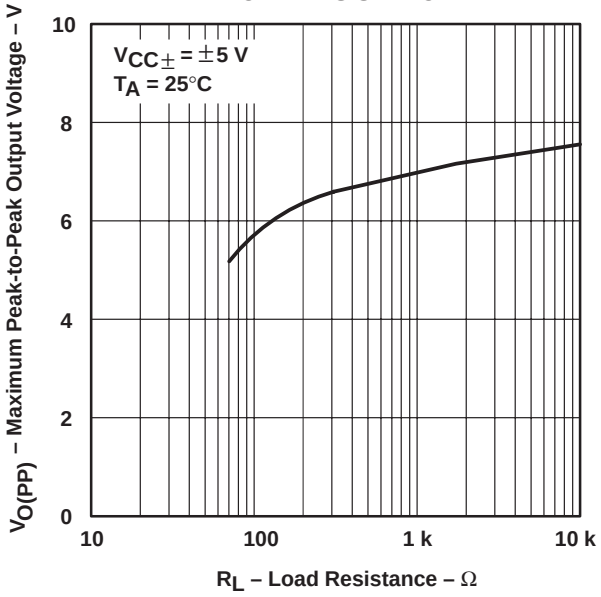


Figure 17

LARGE-SIGNAL DIFFERENTIAL VOLTAGE
AMPLIFICATION AND PHASE SHIFT
vs
FREQUENCY

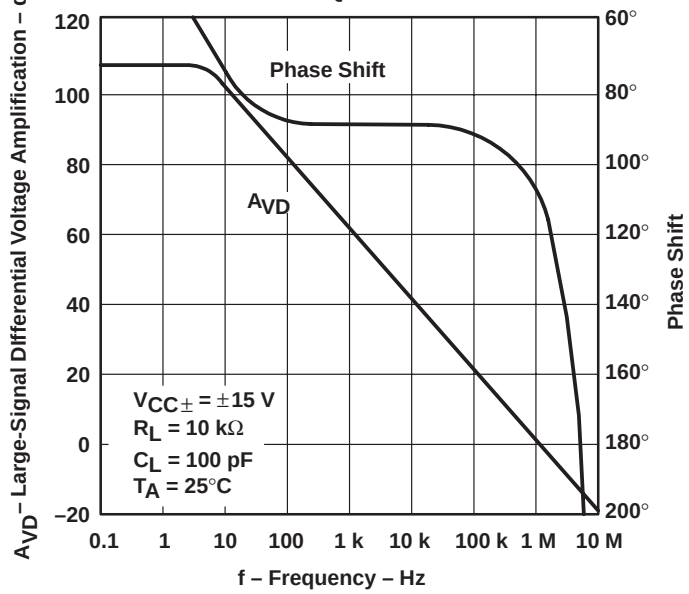


Figure 18

LARGE-SIGNAL VOLTAGE AMPLIFICATION
vs
FREE-AIR TEMPERATURE

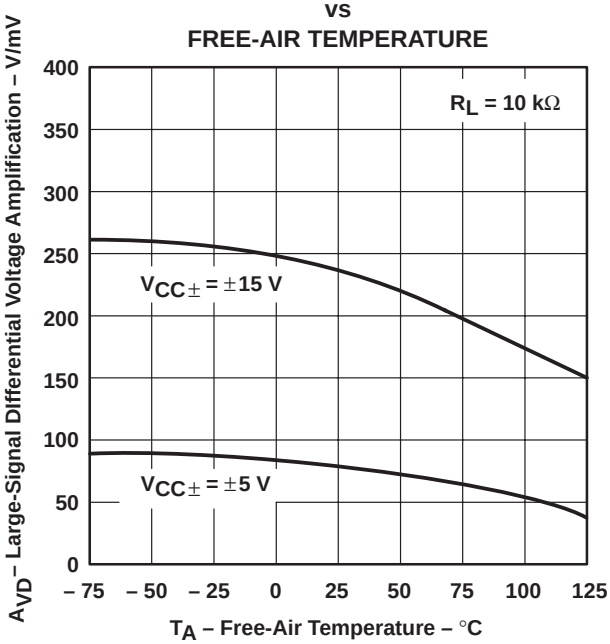


Figure 19

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS†

SHORT-CIRCUIT OUTPUT CURRENT vs ELAPSED TIME

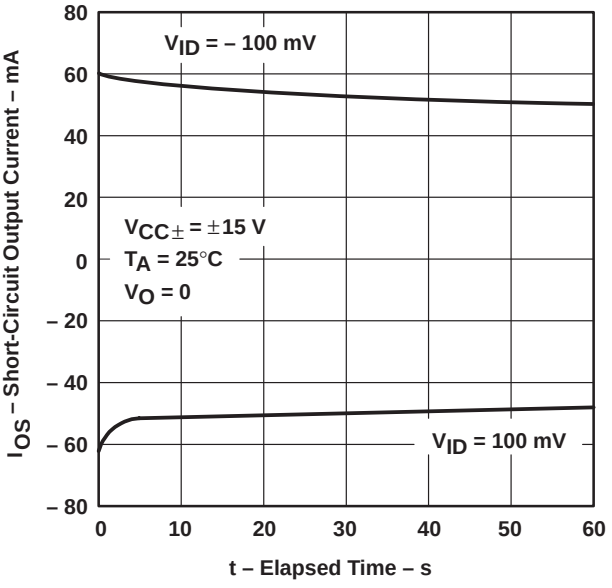


Figure 20

SHORT-CIRCUIT OUTPUT CURRENT vs FREE-AIR TEMPERATURE

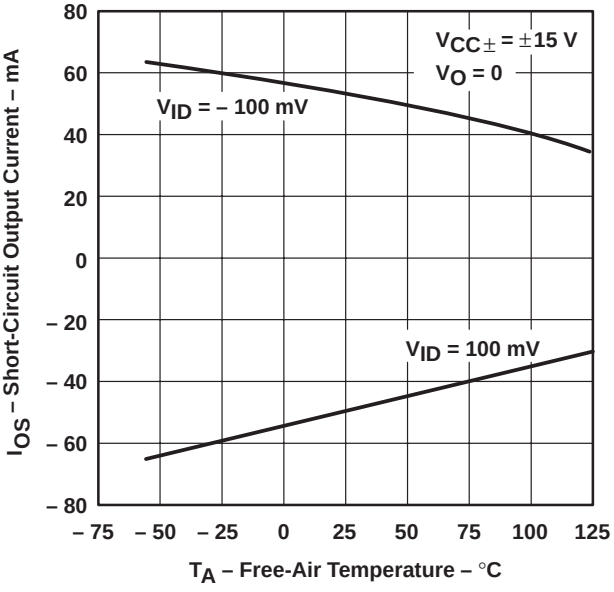


Figure 21

TLE2061 OUTPUT IMPEDANCE vs FREQUENCY

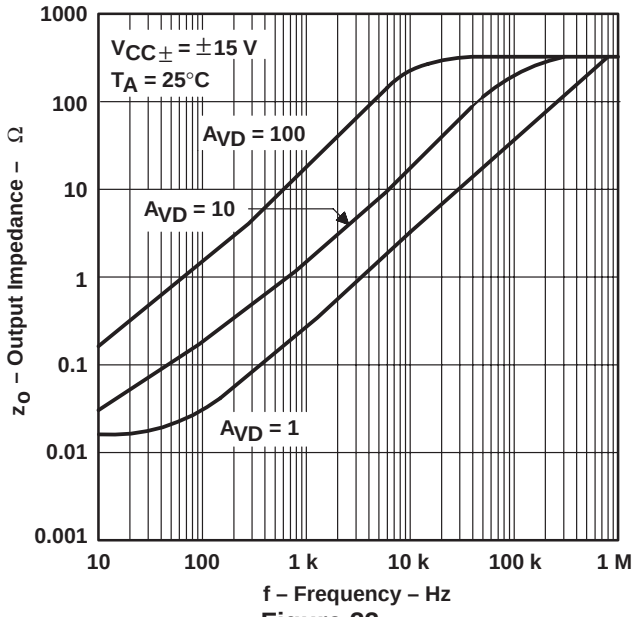


Figure 22

TLE2062 AND TLE2064 OUTPUT IMPEDANCE vs FREQUENCY

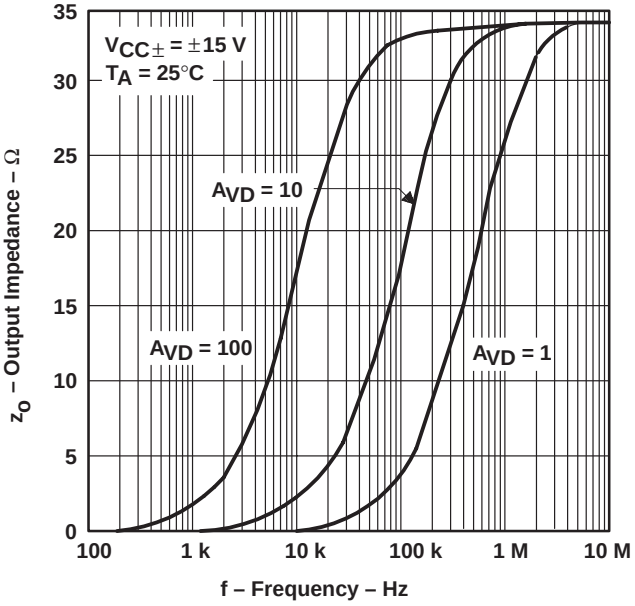


Figure 23

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS†

COMMON-MODE REJECTION RATIO vs FREQUENCY

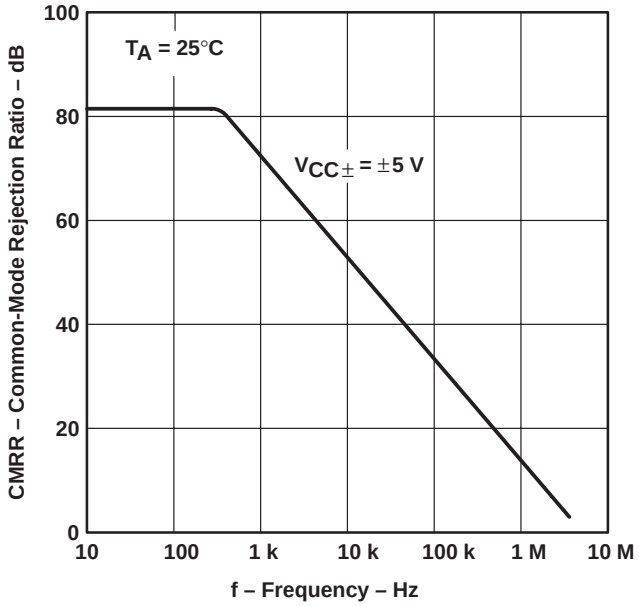


Figure 24

TLE2061 SUPPLY CURRENT vs SUPPLY VOLTAGE

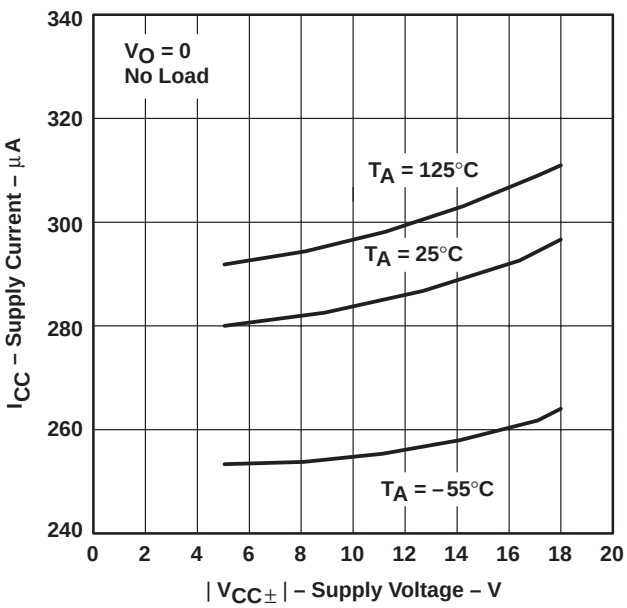


Figure 25

TLE2062 SUPPLY CURRENT vs SUPPLY VOLTAGE

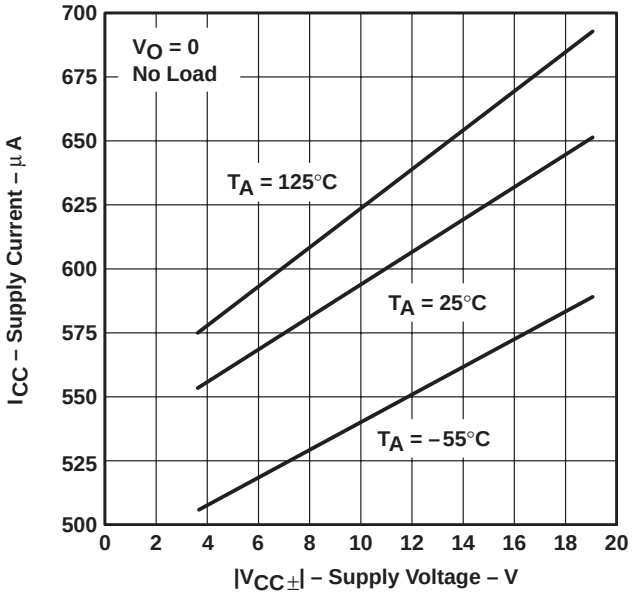


Figure 26

TLE2064 SUPPLY CURRENT vs SUPPLY VOLTAGE

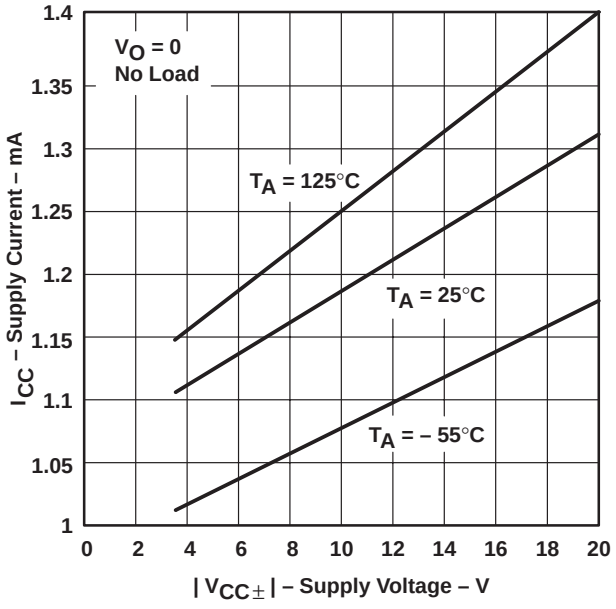


Figure 27

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS†

**TLE2061
SUPPLY CURRENT
vs
FREE-AIR TEMPERATURE**

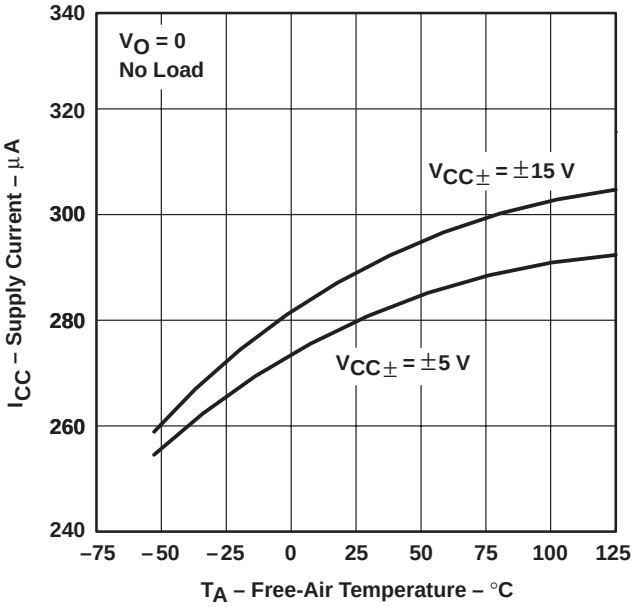


Figure 28

**TLE2062
SUPPLY CURRENT
vs
FREE-AIR TEMPERATURE**

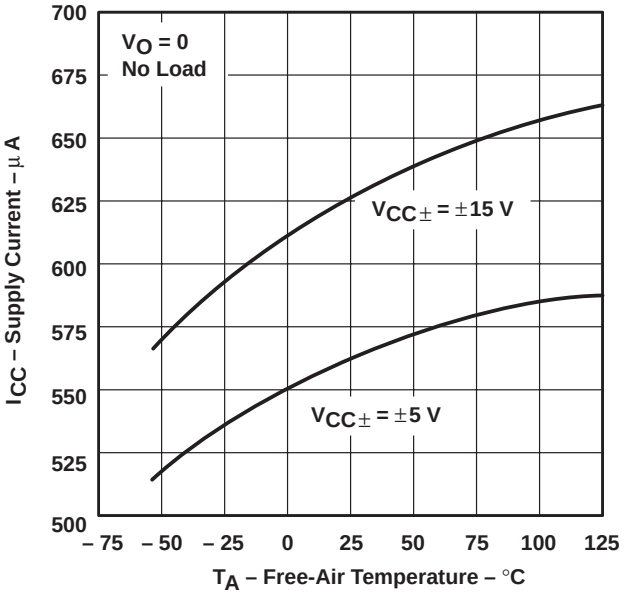


Figure 29

**TLE2064
SUPPLY CURRENT
vs
FREE-AIR TEMPERATURE**

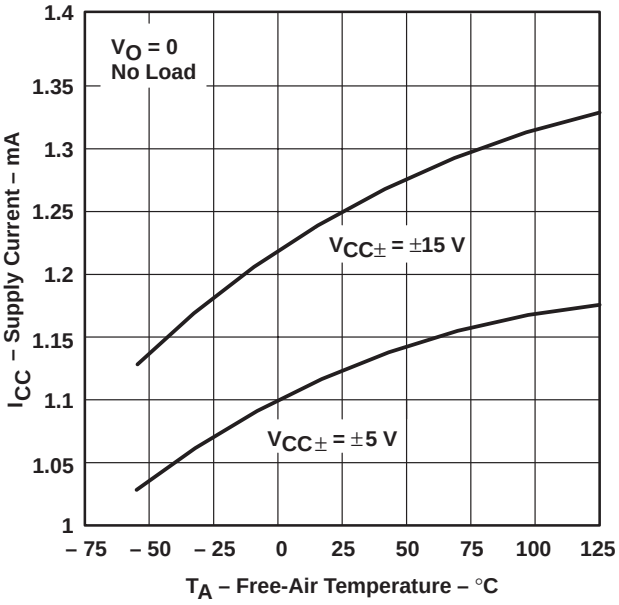


Figure 30

**VOLTAGE-FOLLOWER
SMALL-SIGNAL
PULSE RESPONSE**

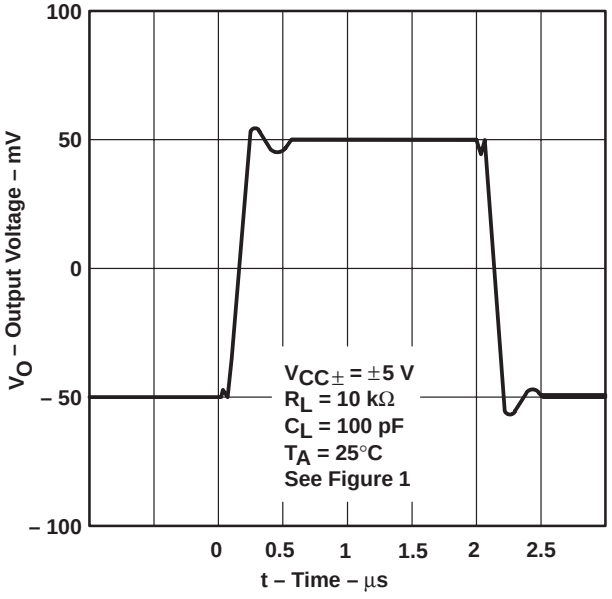


Figure 31

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

TYPICAL CHARACTERISTICS

VOLTAGE-FOLLOWER SMALL-SIGNAL PULSE RESPONSE

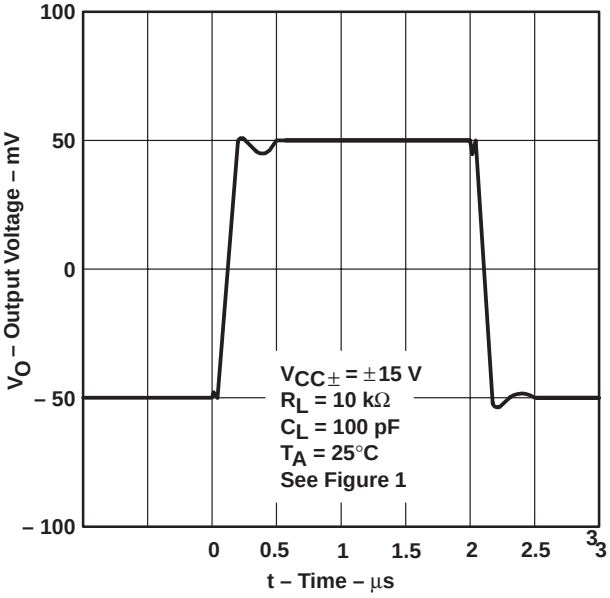


Figure 32

VOLTAGE-FOLLOWER LARGE-SIGNAL PULSE RESPONSE

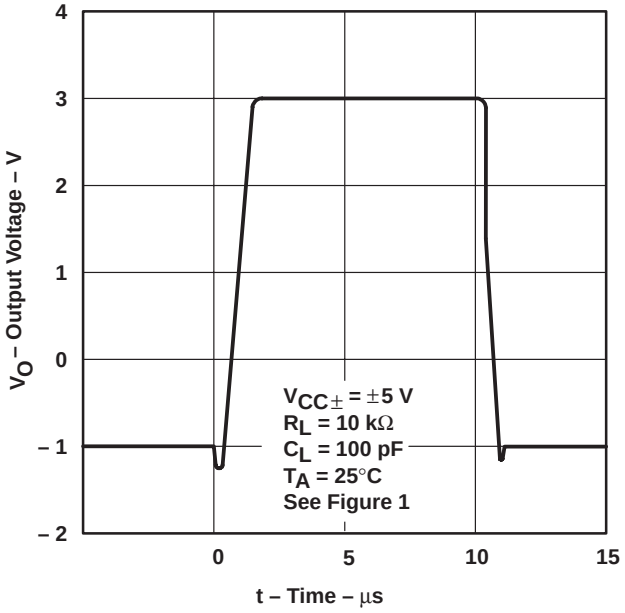


Figure 33

VOLTAGE-FOLLOWER LARGE-SIGNAL PULSE RESPONSE

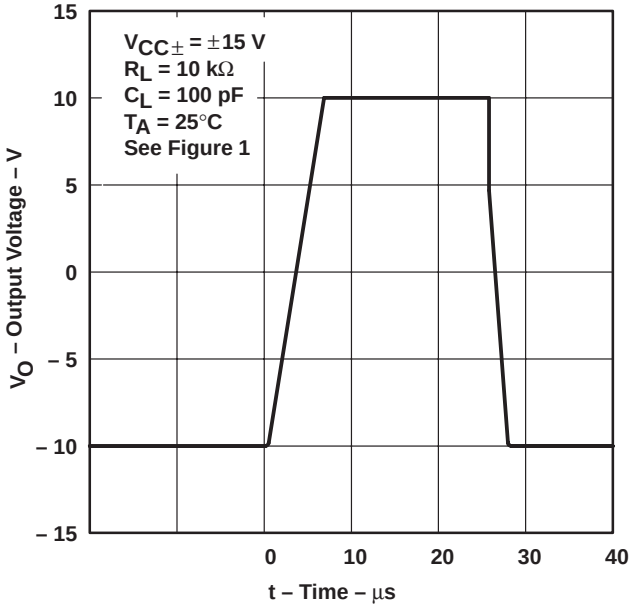


Figure 34

NOISE VOLTAGE (REFERRED TO INPUT) 0.1 TO 10 Hz

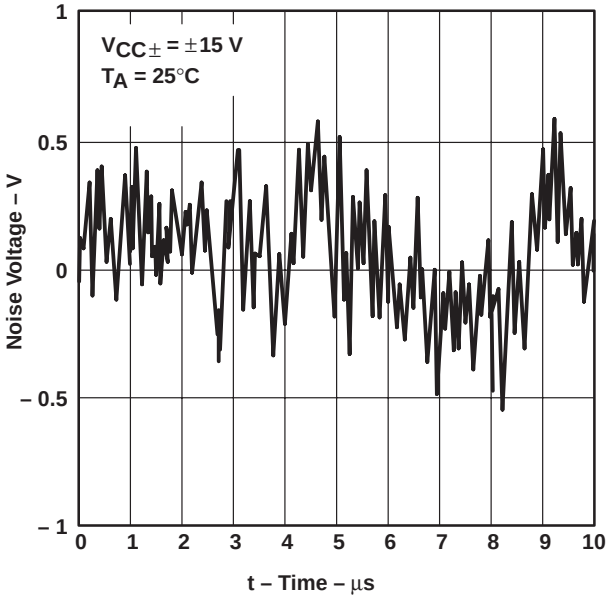


Figure 35

TYPICAL CHARACTERISTICS

EQUIVALENT INPUT NOISE VOLTAGE vs FREQUENCY

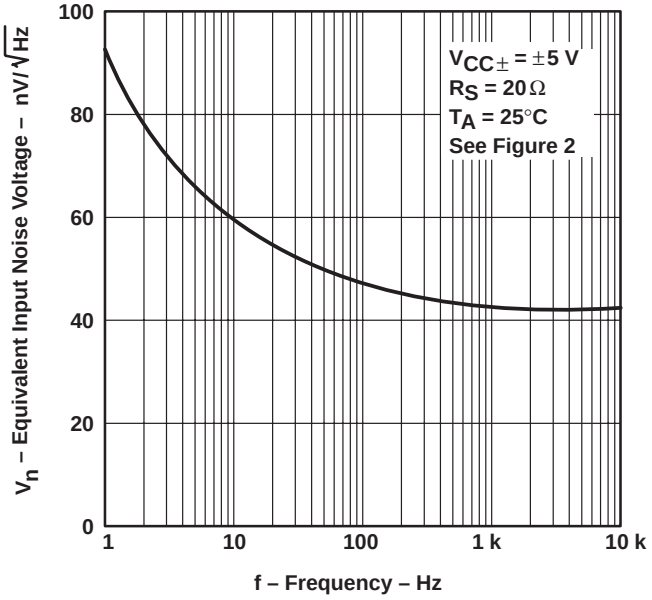


Figure 36

TOTAL HARMONIC DISTORTION vs FREQUENCY

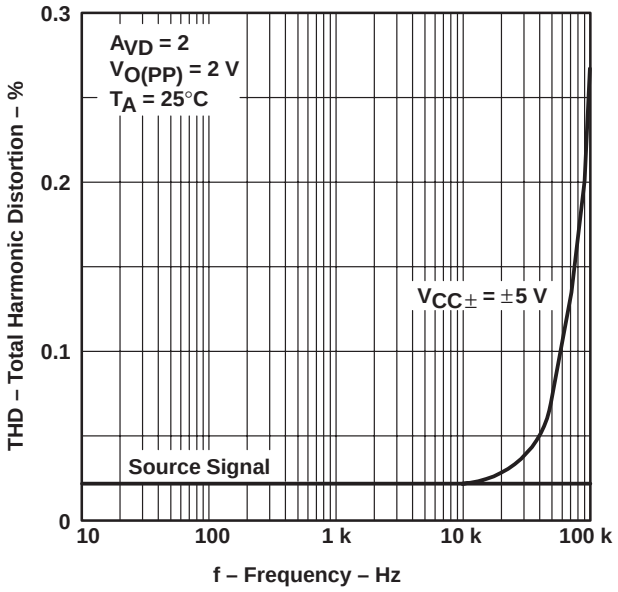


Figure 37

TOTAL HARMONIC DISTORATION vs FREQUENCY

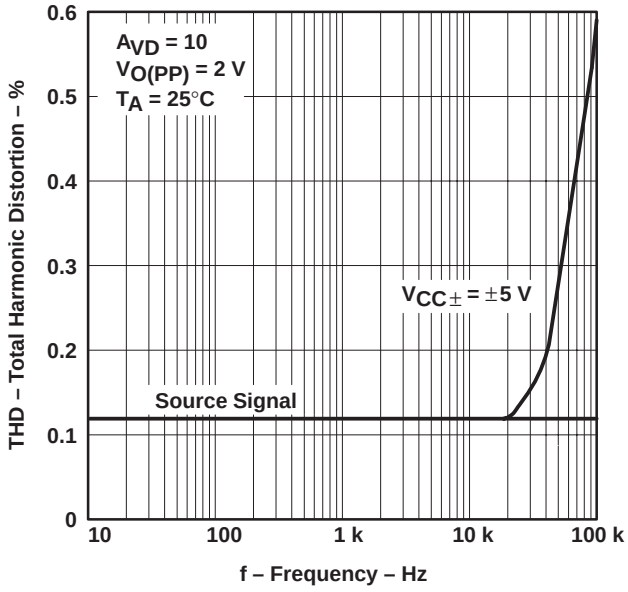


Figure 38

UNITY-GAIN BANDWIDTH vs SUPPLY VOLTAGE

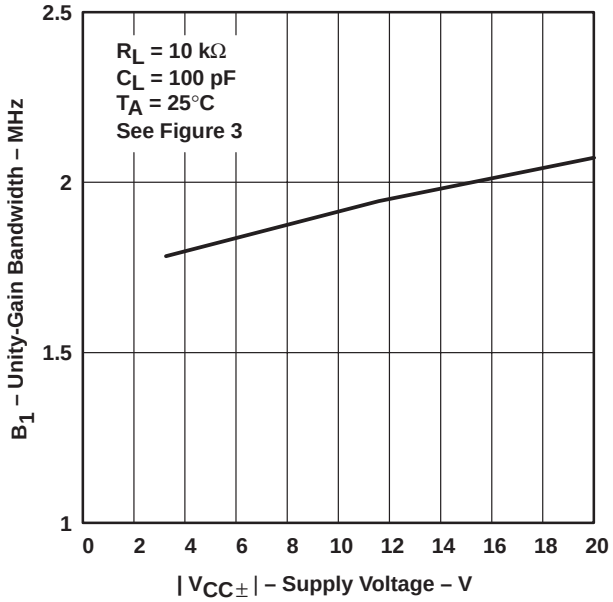


Figure 39

TYPICAL CHARACTERISTICS†

UNITY-GAIN BANDWIDTH vs FREE-AIR TEMPERATURE

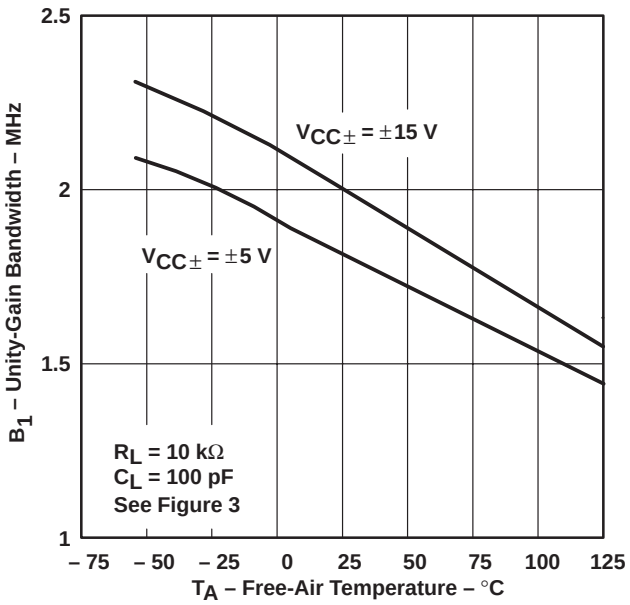


Figure 40

PHASE MARGIN vs SUPPLY VOLTAGE

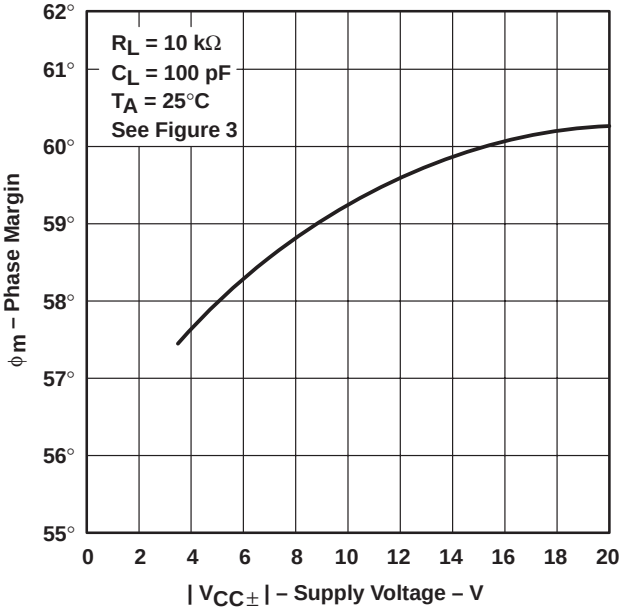


Figure 41

PHASE MARGIN vs LOAD CAPACITANCE

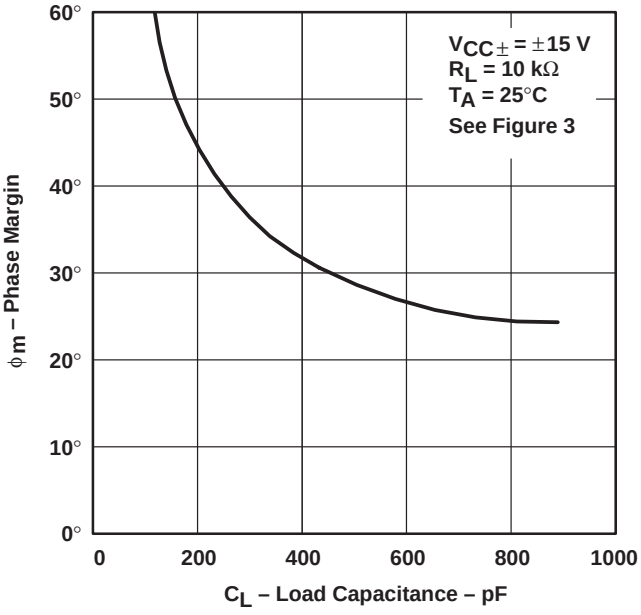


Figure 42

PHASE MARGIN vs FREE-AIR TEMPERATURE

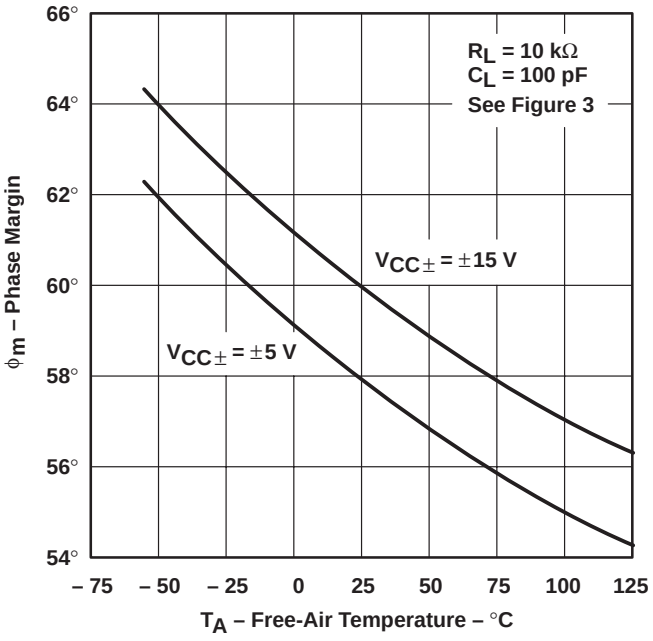


Figure 43

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

APPLICATION INFORMATION

input characteristics

The TLE206x, TLE206xA, and TLE206xB are specified with a minimum and a maximum input voltage that if exceeded at either input could cause the device to malfunction. Because of the extremely high input impedance and resulting low bias current requirements, the TLE206x, TLE206xA, and TLE206xB are well suited for low-level signal processing; however, leakage currents on printed-circuit boards and sockets can easily exceed bias current requirements and cause degradation in system performance. It is good practice to include guard rings around inputs (see Figure 44). These guards should be driven from a low-impedance source at the same voltage level as the common-mode input.

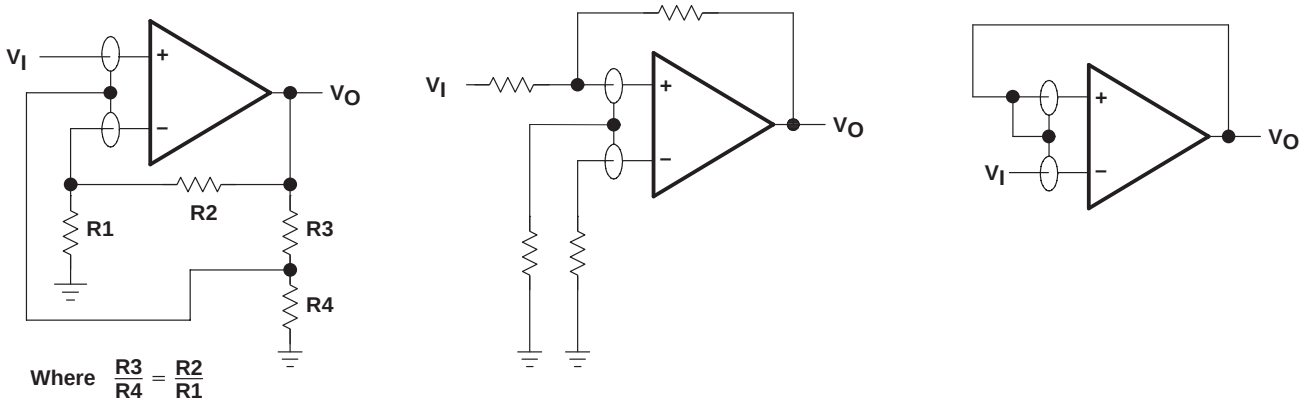


Figure 44. Use of Guard Rings

TLE2061 input offset voltage nulling

The TLE2061 series offers external null pins that can be used to further reduce the input offset voltage. The circuit of Figure 45 can be connected as shown if the feature is desired. When external nulling is not needed, the null pins may be left unconnected.

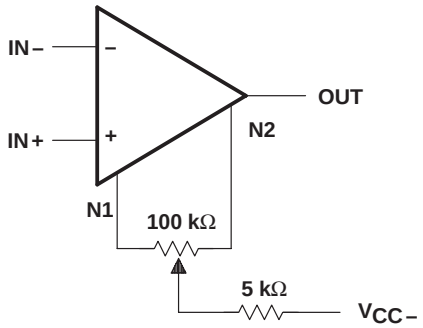


Figure 45. Input Offset Voltage Nulling

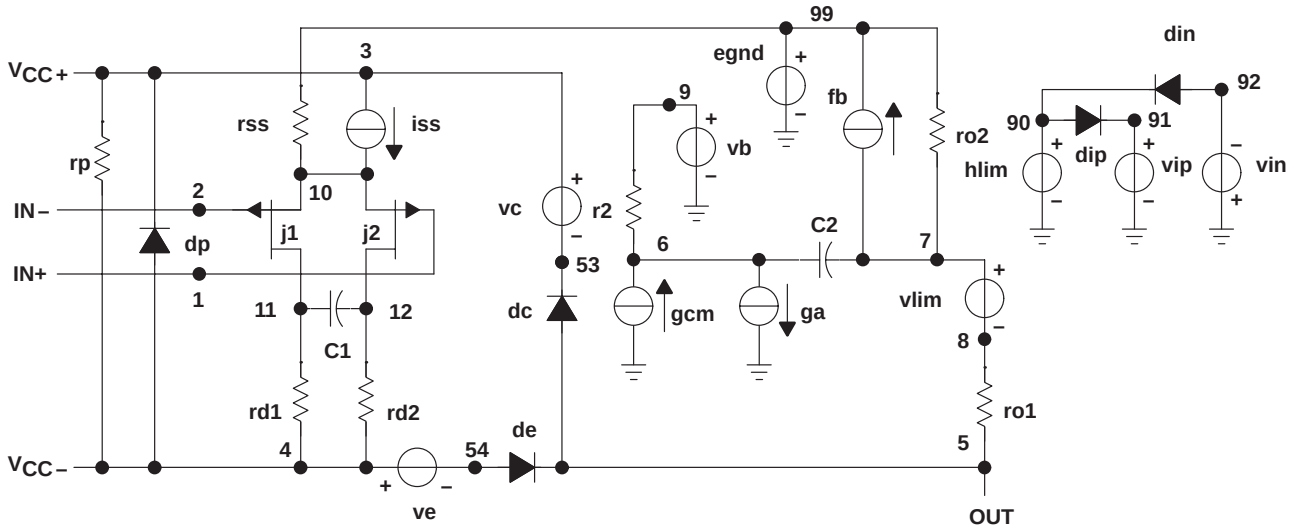
APPLICATION INFORMATION

macromodel information

Macromodel information provided was derived using Microsim *Parts*™, the model generation software used with Microsim *PSpice*™. The Boyle macromodel (see Note 5) and subcircuit in Figure 46 were generated using the TLE206x typical electrical and operating characteristics at 25°C. Using this information, output simulations of the following key parameters can be generated to a tolerance of 20% (in most cases):

- Maximum positive output voltage swing
- Maximum negative output voltage swing
- Slew rate
- Quiescent power dissipation
- Input bias current
- Open-loop voltage amplification
- Unity-gain frequency
- Common-mode rejection ratio
- Phase margin
- DC output resistance
- AC output resistance
- Short-circuit output current limit

NOTE 5: G. R. Boyle, B. M. Cohn, D. O. Pederson, and J. E. Solomon, "*Macromodeling of Integrated Circuit Operational Amplifiers*", *IEEE Journal of Solid-State Circuits*, SC-9, 353 (1974).




```
.subckt TLE2062 1 2 3 4 5
  c1   11  12 1.457E-12
  c2    6   7 15.00E-12
  dc    5  53 dx
  de   54   5 dx
  dlp  90  91 dx
  dln  92  90 dx
  dp    4   3 dx
  egnd 99   0 poly (2) (3,0) (4,0) 0 .5 .5
  fb    7  99 poly (5) vb vc ve vlp
+  vln 0 4.357E6 -4E6 4E6 4E6 -4E6
  ga    6   0 11 12 188.5E-6
  gcm   0   6 10 99 3.352E-9
  iss   3  10 dc 51.00E-6
  hlim 90   0 vlim 1k
  j1   11   2 10 jx
  j2   12   1 10 jx
  r2    6   9 100.0E3
  rd1   4  11 5.305E3
  rd2   4  12 5.305E3
  r01   8   5 280
  r02   7  99 280
  rp    3   4 113.2E3
  rss  10  99 3.922E6
  vb    9   0 dc 0
  vc    3  53 dc 2
  ve   54   4 dc 2
  vlim  7   8 dc 0
  vlp  91  0  dc 50
  vln   0  92 dc 50
.model dx  D(Is=800.0E-18)
.model jx  PJF(Is=2.000E-12 Beta = 423E-6
+ Vto = -1)
.ends
```

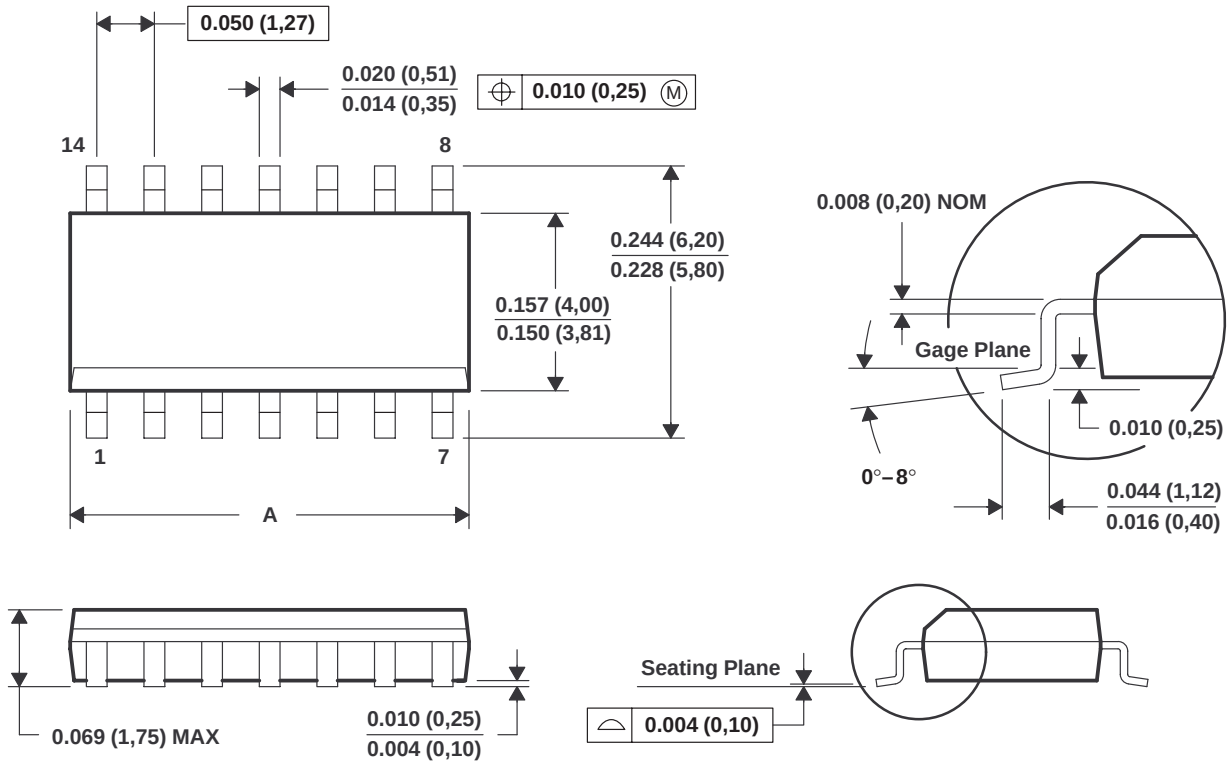
Figure 46. Boyle Macromodel and Subcircuit

PSpice and *Parts* are trademarks of MicroSim Corporation.

MECHANICAL INFORMATION

D (R-PDSO-G)** **PLASTIC SMALL-OUTLINE PACKAGE**

14 PIN SHOWN



DIM \ PINS **	8	14	16
A MAX	0.197 (5,00)	0.344 (8,75)	0.394 (10,00)
A MIN	0.189 (4,80)	0.337 (8,55)	0.386 (9,80)

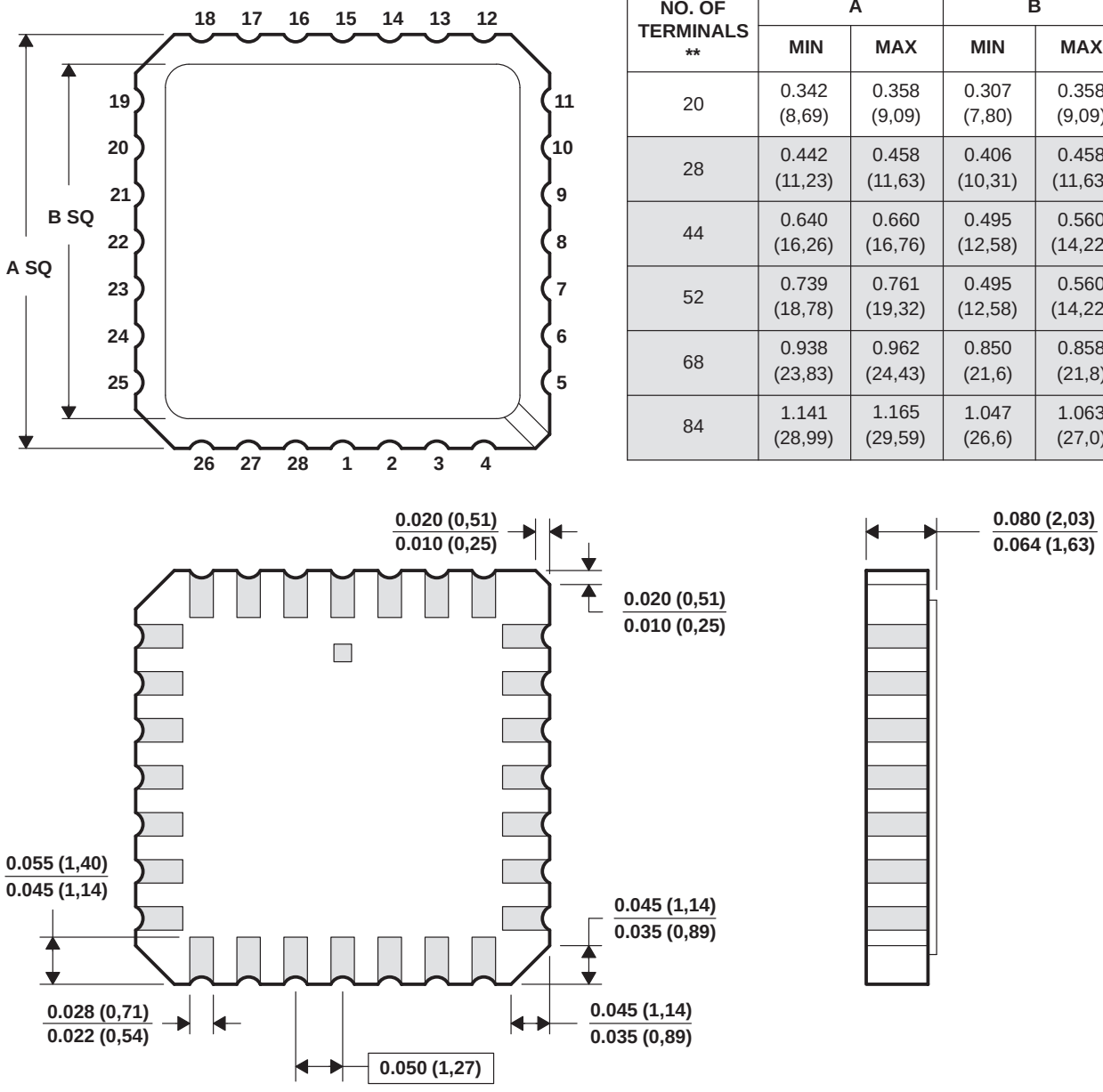
4040047/D 10/96

NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion, not to exceed 0.006 (0,15).
D. Falls within JEDEC MS-012

MECHANICAL INFORMATION

FK (S-CQCC-N)** **LEADLESS CERAMIC CHIP CARRIER**

28 TERMINAL SHOWN



NO. OF TERMINALS **	A		B	
	MIN	MAX	MIN	MAX
20	0.342 (8,69)	0.358 (9,09)	0.307 (7,80)	0.358 (9,09)
28	0.442 (11,23)	0.458 (11,63)	0.406 (10,31)	0.458 (11,63)
44	0.640 (16,26)	0.660 (16,76)	0.495 (12,58)	0.560 (14,22)
52	0.739 (18,78)	0.761 (19,32)	0.495 (12,58)	0.560 (14,22)
68	0.938 (23,83)	0.962 (24,43)	0.850 (21,6)	0.858 (21,8)
84	1.141 (28,99)	1.165 (29,59)	1.047 (26,6)	1.063 (27,0)

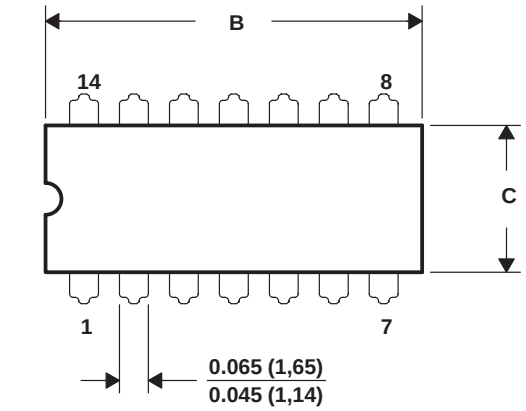
4040140/D 10/96

NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. This package can be hermetically sealed with a metal lid.
D. The terminals are gold plated.
E. Falls within JEDEC MS-004

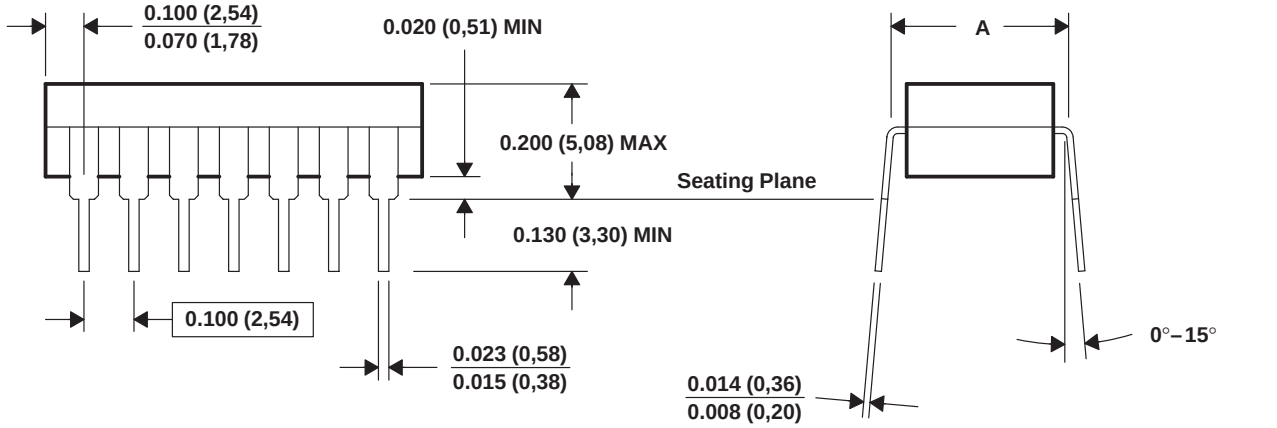
MECHANICAL INFORMATION

J (R-GDIP-T)** **CERAMIC DUAL-IN-LINE PACKAGE**

14 PIN SHOWN



DIM \ PINS **	14	16	18	20
A MAX	0.310 (7,87)	0.310 (7,87)	0.310 (7,87)	0.310 (7,87)
A MIN	0.290 (7,37)	0.290 (7,37)	0.290 (7,37)	0.290 (7,37)
B MAX	0.785 (19,94)	0.785 (19,94)	0.910 (23,10)	0.975 (24,77)
B MIN	0.755 (19,18)	0.755 (19,18)	—	0.930 (23,62)
C MAX	0.280 (7,11)	0.300 (7,62)	0.300 (7,62)	0.300 (7,62)
C MIN	0.245 (6,22)	0.245 (6,22)	0.245 (6,22)	0.245 (6,22)

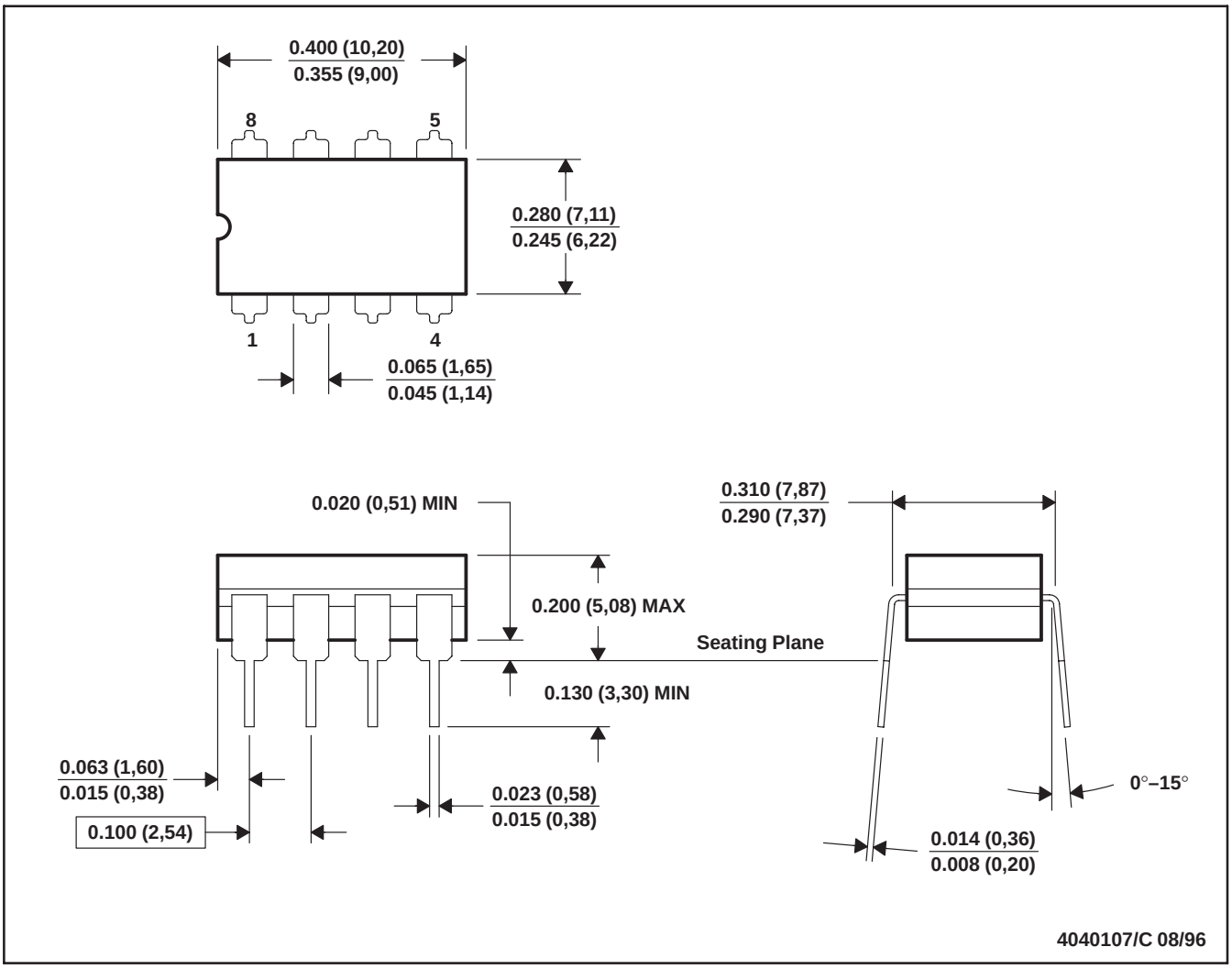


4040083/C 08/96

NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. This package can be hermetically sealed with a ceramic lid using glass frit.
D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
E. Falls within MIL-STD-1835 GDIP1-T14, GDIP1-T16, GDIP1-T18, and GDIP1-T20

MECHANICAL INFORMATION

JG (R-GDIP-T8) **CERAMIC DUAL-IN-LINE PACKAGE**



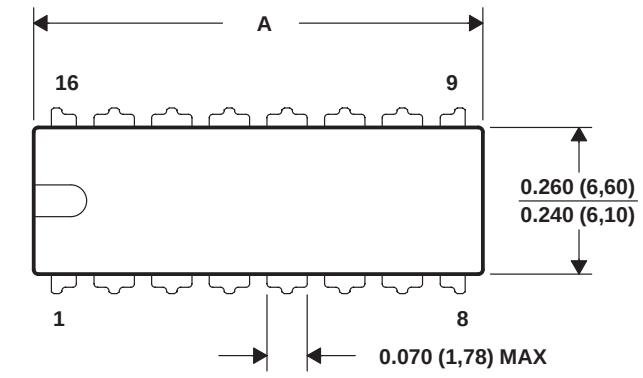
NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. This package can be hermetically sealed with a ceramic lid using glass frit.
D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
E. Falls within MIL-STD-1835 GDIP1-T8

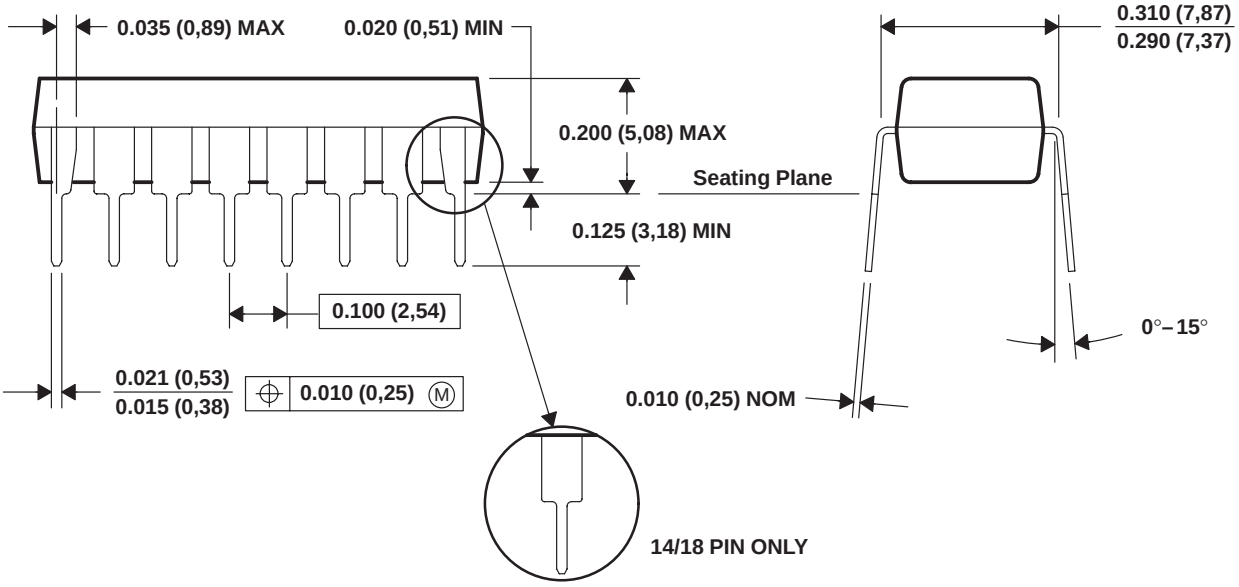
MECHANICAL INFORMATION

N (R-PDIP-T)** **PLASTIC DUAL-IN-LINE PACKAGE**

16 PIN SHOWN

DIM \ PINS **	14	16	18	20
A MAX	0.775 (19,69)	0.775 (19,69)	0.920 (23.37)	0.975 (24,77)
A MIN	0.745 (18,92)	0.745 (18,92)	0.850 (21.59)	0.940 (23,88)



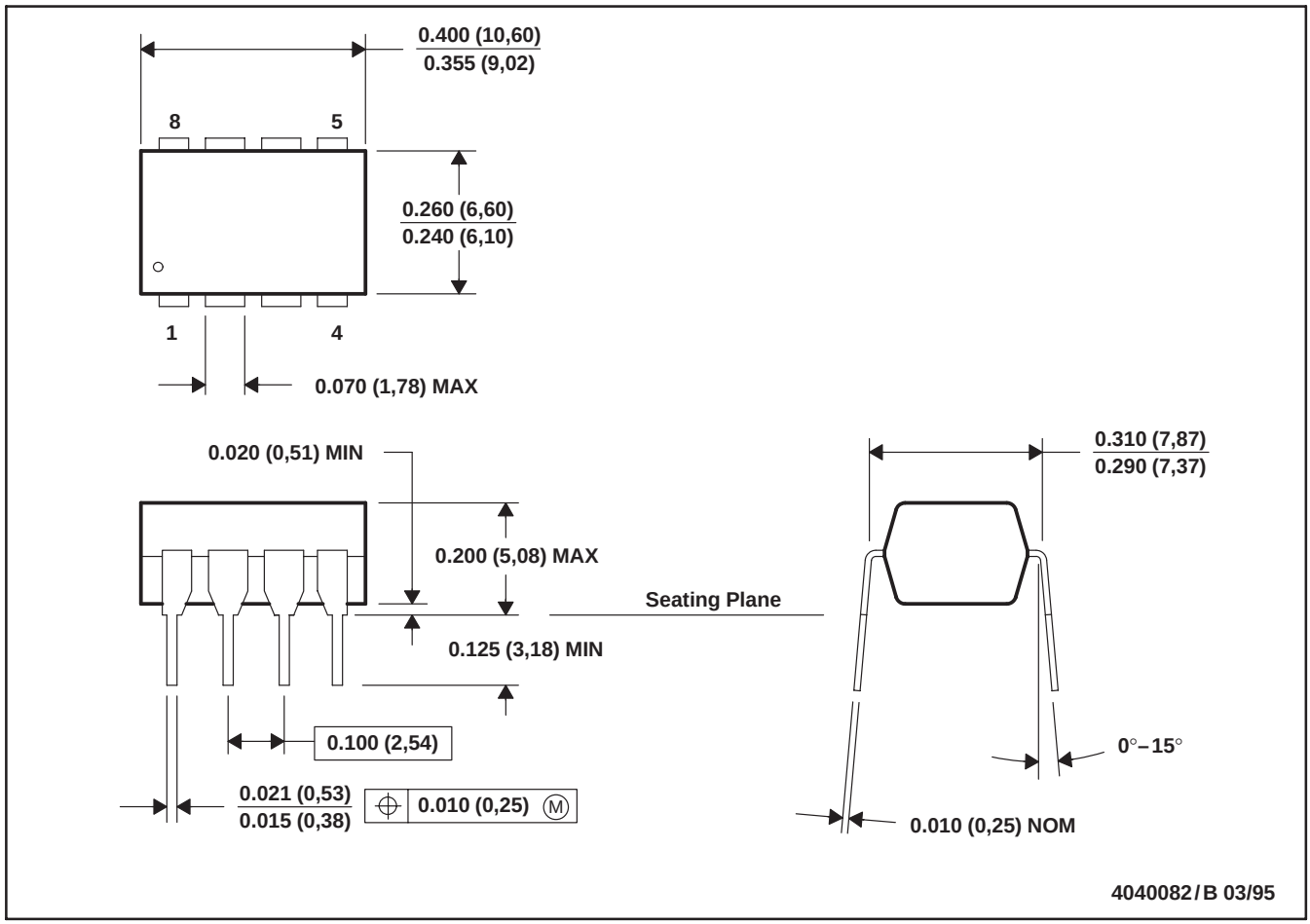


4040049/C 08/95

NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. Falls within JEDEC MS-001 (20 pin package is shorter then MS-001.)

MECHANICAL INFORMATION

P (R-PDIP-T8) **PLASTIC DUAL-IN-LINE PACKAGE**

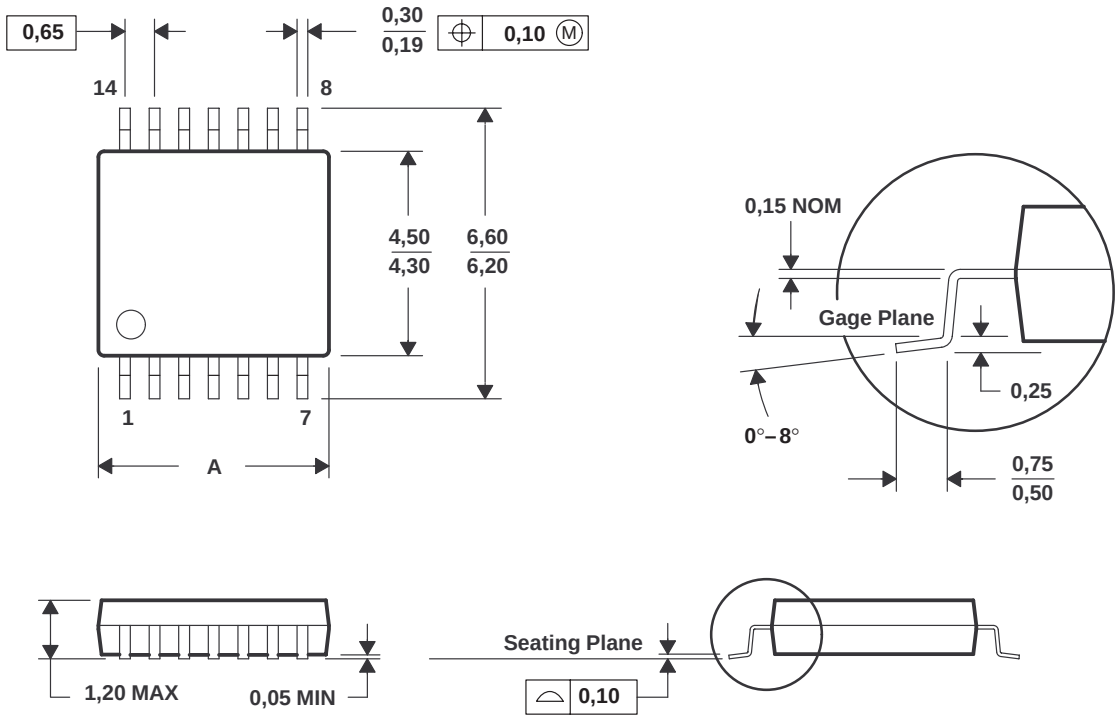


NOTES: A. All linear dimensions are in inches (millimeters).
B. This drawing is subject to change without notice.
C. Falls within JEDEC MS-001

MECHANICAL INFORMATION

PW (R-PDSO-G)** **PLASTIC SMALL-OUTLINE PACKAGE**

14 PIN SHOWN



DIM \ PINS **	8	14	16	20	24	28
A MAX	3,10	5,10	5,10	6,60	7,90	9,80
A MIN	2,90	4,90	4,90	6,40	7,70	9,60

4040064/E 08/96

NOTES: A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
D. Falls within JEDEC MO-153

IMPORTANT NOTICE

Texas Instruments and its subsidiaries (TI) reserve the right to make changes to their products or to discontinue any product or service without notice, and advise customers to obtain the latest version of relevant information to verify, before placing orders, that information being relied on is current and complete. All products are sold subject to the terms and conditions of sale supplied at the time of order acknowledgement, including those pertaining to warranty, patent infringement, and limitation of liability.

TI warrants performance of its semiconductor products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

CERTAIN APPLICATIONS USING SEMICONDUCTOR PRODUCTS MAY INVOLVE POTENTIAL RISKS OF DEATH, PERSONAL INJURY, OR SEVERE PROPERTY OR ENVIRONMENTAL DAMAGE ("CRITICAL APPLICATIONS"). TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS. INCLUSION OF TI PRODUCTS IN SUCH APPLICATIONS IS UNDERSTOOD TO BE FULLY AT THE CUSTOMER'S RISK.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards must be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance or customer product design. TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used. TI's publication of information regarding any third party's products or services does not constitute TI's approval, warranty or endorsement thereof.